

Evaluating & improving fault localization techniques

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Abstract—Most fault localization techniques take as input a faulty program, and produce as output a ranked list of suspicious code locations at which the program may be defective. When researchers propose a new fault localization technique, they typically evaluate it on programs with known faults. The technique is scored based on where in its output list the defective code appears. This enables the comparison of multiple fault localization techniques to determine which one is better.

Previous research has evaluated fault localization techniques using artificial faults, generated either by mutation tools or manually. In other words, previous research has determined which fault localization techniques are best at finding artificial faults. However, it is not known which fault localization techniques are best at finding real faults. It is not obvious that the answer is the same, given previous work showing that artificial faults have both similarities to and differences from real faults.

We performed a replication study to evaluate 10 claims in the literature that compared fault localization techniques (from the spectrum-based and mutation-based families). We used 3242 artificial faults in 6 real-world programs. Our results support 7 of the previous claims as statistically significant, but only 3 as having non-negligible effect sizes. Then, we evaluated the same 10 claims, using 323 *real* faults from the 6 programs. Every previous result was refuted or was statistically and practically insignificant. Our experiments show that artificial faults are not useful for predicting which fault localization techniques perform best on real faults.

In light of these results, we identified a design space that includes many previously-studied fault localization techniques as well as hundreds of new techniques. We experimentally determined which factors in the design space are most important, using an overall set of 395 *real* faults. Then, we extended this design space with new techniques. Several of our novel techniques outperform all existing techniques, notably in terms of ranking defective code in the top-5 or top-10 reports.

I. INTRODUCTION

A fault localization technique (for short, FL technique) directs a programmer’s attention to specific parts of a program. Given one or more failing test cases and zero or more passing test cases, a FL technique outputs a (typically, sorted) list of suspicious program locations, such as lines, statements, or declarations. The FL technique uses heuristics to determine which program locations are most *suspicious*—that is, most likely to be erroneous and associated with the fault. A programmer can save time during debugging by focusing attention on the most suspicious locations [17]. Another use is to focus a defect repair tool on the parts of the code that are most likely to be buggy.

Dozens of fault localization techniques have been proposed [52]. It is desirable to evaluate and compare these techniques, both so that practitioners can choose the ones that help them solve their debugging problems, and so that researchers can better build new fault localization techniques.

A fault localization technique is valuable if it works on real faults. Although some real faults (mostly 35 faults in the single small numerical program space [48]) have been used in previous comparisons [52] of fault localization techniques, the vast majority of faults used in such comparisons are fake faults, mostly mutants. The artificial faults were mutants automatically created by a tool [30], [31], [57], or mutant-like manually-seeded faults created by students [51], [53] or researchers [18].

Artificial faults such as mutants differ from real faults in many respects, including their size, their distribution in code, and their difficulty of being detected by tests [24]. It is possible that an evaluation of FL techniques on real faults would yield different outcomes than previous evaluations on mutants. If so, previous recommendations would need to be revised, and practitioners and researchers should choose different techniques to use and improve. It is also possible that an evaluation of FL techniques on real faults would yield the same recommendations, thus resolving a cloud of doubt that currently hangs over the field. Either result would be of significant scientific interest. The results also have implications beyond fault localization itself. For instance, it would help to indicate which fault localization approaches, if any, should be used to guide automated program repair techniques [43].

This paper compares fault localization techniques on real vs. artificial faults. Techniques that localize artificial faults best do *not* perform best on real faults. Our experiments are based on 7 previously-studied fault localization techniques from the spectrum-based and mutation-based families.

The contributions of this paper include:

- A replication study that repeats and extends previous experiments, comparing 7 fault localization techniques on 3242 artificial faults. We mitigated threats to internal validity by re-implementing all the techniques in a single infrastructure and using the same experimental scripts, faults, and other experimental variables. Our results confirm 70% of previously-reported comparisons (such as “Ochiai is better than

Tarantula” [30], [31], [37], [51], [57]) and refute 30%.

- A new study that compares the 7 fault localization techniques on 323 *real* faults. The ranking does not agree with any previous results from artificial faults! 40% of the previous results are reversed; for example, Metallaxis is better than Ochiai on artificial faults [39], but Ochiai is better than Metallaxis on real faults. The other 60% of the results are statistically insignificant; for example, DStar is better than Tarantula on artificial faults [21], [30], [51], but on real faults there is no significant difference between the two techniques. These results indicate that artificial faults (e.g., mutants) are not an adequate substitute for real faults, for the task of evaluating a fault localization technique.
- An explication of the design space of fault localization techniques. Previous work made different, sometimes undocumented, choices for factors other than the formula. We exhaustively evaluated all these factors. We found that formula, which most papers have exclusively focused on, is one of the least important factors. We also added new factors to the design space, thereby creating new hybrid fault localization techniques that combine the best of previous techniques.
- An evaluation of all the FL techniques generated by the design space, with respect to how well they localize real faults. We found new techniques that are statistically significantly better than any previous technique, though with small effect sizes. More importantly, they do much better in terms of including the correct answer (the actual faulty statement) within the top-5 or top-10 statements of their output. Our results indicate how to make the most of current approaches, and they indicate that significant advances in fault localization will come from focusing on different issues than in the past.
- Our methodology addresses multi-line faults, faults of omission, and other real-world issues, both in the design of FL techniques and in the experimental protocol for evaluating them.

The rest of the paper is structured as follows. Section II describes the traditional approaches that have been commonly used to evaluate fault localization techniques and our extensions to make them applicable to real faults. Section III describes the subjects of investigation, including the studied fault localization techniques and the used programs, real faults, and test suites. Sections IV to VII describe our four empirical studies in detail. More specifically, section IV reports on our replication study using artificial faults, section V reports on our replication study using real faults, section VI defines and explores a design space for fault localization techniques, and section VII proposes and evaluates new fault localization techniques. Section VIII discusses threats to validity regarding all four studies. Section IX describes related work, section X highlights lessons learned, and section XI concludes. An appendix contains tables and figures that support claims made in the body of the paper.

This paper is an extended version of a conference paper [41]. It adds more examples, data, and analyses.

II. EVALUATING FAULT LOCALIZATION

Many studies have evaluated and compared FL techniques [3]–[6], [20], [21], [30], [31], [36], [37], [39], [45], [51], [57]. Table I summarizes these studies in terms of the programs used, the number of real and artificial faults considered, and the resulting ranking of techniques. The majority of studies revolve around the same set of programs and use largely artificial faults. This section explains how a fault localization technique’s output can be evaluated.

A. Evaluation metrics

A fault localization technique T takes as input a program P and a test suite with at least one failing test, and it produces as output a sorted list of suspicious program locations, such as lines, statements, or declarations. For concreteness, this paper uses statements as the locations, but the ideas also apply to other levels of granularity.

Given a fault localization technique T and a program P of size N with a single known defective statement d , a numerical measure of the quality of the fault localization technique can be computed as follows [42], [47]: (1) run the FL technique to compute the sorted list of suspicious statements; (2) let n be the rank of d in the list; (3) use a metric proposed in the literature to evaluate the effectiveness of a FL technique, e.g., LIL [36], T-score [32], Expense [20], or EXAM score [50].¹ For concreteness this paper uses EXAM score, which is the most popular metric, but our results generalize to the others.

LIL [36] measures the effectiveness of a fault localization technique for automated program repair. T-score [32] computes the percentage of components that a developer *would not have* to inspect before finding the first faulty one. By contrast, Expense [20] and EXAM score [50] compute the percentage of components that a developer *would have* to inspect until finding the first faulty one—that is, the cost of going through the ranked list to find the faulty component. Both Expense and EXAM score compute n/N in which N is the total number of executed statements for Expense, and N is the total number of statements in the program for EXAM score. The score ranges between 0 and 1, and smaller numbers are better.

B. Extensions to fault localization evaluation

The standard technique for evaluating fault localization, described in section II-A, handles defects that consist of a change to one executable statement in the program, as is the case for mutants. To evaluate fault localization on real faults, we had to extend the methodology to account for ties in the suspiciousness score, multi-line statements, multi-statement faults, faults of omission, and defective non-executable code such as declarations.

¹These scores are different than the “suspiciousness score” that the fault localization technique may use for constructing the sorted list of suspicious program statements.

TABLE I

SELECTED FAULT-LOCALIZATION STUDIES. OUR RESULTS (BOTTOM) UPHOLD PREVIOUS RESULTS ON ARTIFICIAL FAULTS BUT NOT ON REAL FAULTS.

Ref.	Lang.	Ranking (from best to worst)	Programs	kLOC	Artif. faults	Real faults
[20]	C	Tarantula	Siemens	3	122	-
[4]	C	Ochiai, Tarantula	Siemens	3	120	-
[3]	C	Ochiai, Tarantula	Siemens, space	12	128	34
[5]	C	Barinel, Ochiai, Tarantula	Siemens, space, gzip, sed	31	141	38
[6]	C	Tarantula	Concordance	2	200	13
[37]	C	Op2, Ochiai, Tarantula	Siemens, space	12	132	32
[39]	C	Metallaxis, Ochiai	Siemens, space, flex, grep, gzip	45	859	12
[31]	C	Ochiai, Tarantula	Siemens, space, NanoXML, XML-Security	41	164	35
[51]	C	DStar, Ochiai, Tarantula	Siemens, space, ant, flex, grep, gzip, make, sed, Unix	155	436	34
[36]	C	MUSE, Op2, Ochiai	space, flex, grep, gzip, sed	54	11	3
[57]	Java	Ochiai, Tarantula	JExel, JParsec, Jaxen, Commons Codec, Commons Lang, Joda-Time	108	1800	-
[21]	C & Java	DStar, Tarantula	printtokens, printtokens2, schedule, schedule2, totinfo, Jtcas, Sorting, NanoXML, XML-Security	32	104	-
[30]	C	DStar, Ochiai, Tarantula	Siemens, space, NanoXML, XML-Security	41	165	35
this	Java	Metallaxis, Op2, DStar, Ochiai, Barinel, Tarantula, MUSE	JFreeChart, Closure, Commons Lang, Commons Math, Joda-Time	321	3242	-
this	Java	{DStar ≈ Ochiai ≈ Barinel ≈ Tarantula}, Op2, Metallaxis, MUSE	JFreeChart, Closure, Commons Lang, Commons Math, Joda-Time	321	-	323

represents manually-seeded artificial faults, and represents mutation-based artificial faults. The Siemens set is printtokens, printtokens2, replace, schedule, schedule2, tcas, and totinfo. The Unix set is Cal, Checkeq, Col, Comm, Crypt, Look, Sort, Spline, Tr, and Uniq.

1) *Ties in the suspiciousness score:* Most fault localization techniques first compute a suspiciousness score for each program statement, and then sort statements according to suspiciousness score in order to produce a ranked list of program statements, which is the FL technique’s output. When two statements have the identical suspiciousness score, then an arbitrary sorting choice could affect the *EXAM* score.

We compute the expected *EXAM* score, assuming that the sorting function breaks ties arbitrarily. That is, when multiple statements have the same suspiciousness score, then all of them are treated as being the *n*th element in the output, where *n* is their average rank [47], [52].

2) *Multi-line program statements:* A single statement may span multiple lines in a program. Some FL techniques give reports in terms of lines and some in terms of statements. To permit consistent comparison, our methodology converts them all to report in terms of program statements. Any FL tool report that is within a statement is automatically converted to being a report about the first line of the smallest enclosing statement. In our experiments, there were never duplicate reports for a single statement, but it would be possible to remove all but the first one.

3) *Multi-statement faults:* Existing evaluation metrics, such as the *EXAM* score, are limited as they assume that a single program statement is defective. This assumption holds for mutants and often other artificial faults. However, 76% of real-world bug fixes span multiple statements [23]. To evaluate a fault localization technique on a multi-statement fault, we need to define when the fault is considered to be localized: is it sufficient for the technique to propose any defective statement, or must it propose all defective statements? Rather than making assumptions about a particular *debugging scenario* (e.g., experienced developer vs. novice developer vs. automated repair tool), our study evaluates the fault localization techniques for three debugging scenarios:

- 1) **Best-case:** Any one defective statement needs to be localized to understand and repair the defect.
- 2) **Worst-case:** All defective statements need to be localized to understand and repair the defect.
- 3) **Average-case:** 50% of the defective statements need to be localized to understand and repair the defect.

Note that these debugging scenarios are equivalent for single-statement faults. All of our the experimental results are generally consistent for the three scenarios.

4) *Faults of omission:* In 30% of cases [23], a bug fix consists of adding new code rather than changing existing code. The defective program contains no defective statement: every expression, statement, and declaration in the program is correct but some are missing. Previous studies on the effectiveness of fault localization have not reported whether and how this issue was addressed. Wong et al. [15] suggested that analyzing the code around statements with a high suspiciousness score, and noticing unexpected executions of some statements, could be a first step to identify a fault of omission. In the following, we describe our methodology to deal with this issue.

A FL technique communicates with the programmer in terms of the program’s representation: statements of source code. A FL technique is most useful if it identifies the statement in the source code the programmer needs to change. Therefore, when a bug fix involves inserting code, the technique should report the textually immediately following statement. Ideally, this is the next statement, which is exactly where the programmer should insert the code. However, many FL techniques have a serious limitation: they do not rank or report lines consisting of scoping braces, such as the final } of a method definition, even though that would be the best program location to report when the insertion is at the end of a method. To avoid disadvantaging such techniques, we also count the current last statement as a correct report. Figure 1 shows examples.

A more serious complication is that the developer inserted

```

1 public boolean updateState(State s) {
2+   if (!flag)
3+     return false;
4   setState(s); // goal report
5   return true;
6 }

1 public boolean updateState(State s) {
2+   if (flag)
3+     setState(s); // goal report
4   return true;
5 }

1 public boolean updateState(State s) {
2+   if (flag) {
3+     setState(s); // goal report for "if (flag)"
4     otherStatement();
5     return true; // goal report for "return false"
6+   }
7+   return false;
8 }

```

Fig. 1. Faults of omission and goal statements for reporting them. For the third example, line 8 (the final `}`) would be a better goal report for `return false;`, but current FL techniques do not report it and so we count the preceding `return true;` statement as also a correct report.

the new code at some statement, but other statements might be equally valid choices for a bug fix. Consider the following example, drawn from the patch for Closure-15 in Defects4J [23]:

```

1  if (n.isCall() && ...)
2    return true;
3  if (n.isNew() && ...)
4    return true;
5+ if (n.isDelProp())
6+   return true;
7  for (Node c = n.getFirstChild(); ...) {
8    ...

```

The programmer could have inserted the missing conditional before line 1, between lines 2 and 3, or where it actually was inserted. A FL technique that reports any of those statements is just as useful as one that reports the statement the programmer happened to choose.

For every real fault of omission, we manually determined the set of *candidate* locations at which a code block could be inserted to fix the defect (lines 1, 3, and 5 in the example above). We consider a fault localization technique to identify an omitted statement as soon as any candidate location appears in the FL technique’s output. (A multi-statement fault may require localizing multiple omitted or fixed statements.)

5) *Faults in non-ranked statements:* Some fault localization techniques have limitations in that they fail to report some statements in the program. Here are examples:

Non-executable code (declarations)

All the fault localization techniques that we evaluate have a weakness in that they only output a list of suspicious statements; they never report a declaration in their list of suspicious locations.

However, a non-executable declaration can be faulty, such as a supertype declaration (in Java, an `extends` or `implements` clause in a class declaration) or the data type in a field or variable declaration. In the Defects4J database of real-world faults [23], 4% of real faults involve some non-executable code locations and 3% involve *only* non-executable code locations.

Non-mutable statements: the mutation-based FL techniques that we evaluate have a weakness in that they only output a list of mutable statements. Some faulty, executable statements are not mutable due to compiler restrictions. For example, deleting or incorrectly moving a `break` or `return` statement might cause compilation errors due to the violation of control-flow properties enforced by the compiler. In the Defects4J database of real-world faults [23], 10% of real faults involve a non-mutable yet executable statement.

Previous studies on the effectiveness of fault localization have not considered faults in non-ranked statements. We ensure that the ranked list of statements produced by a FL technique always contains every statement in the program, by adding any missing statement at the end of the ranking. If a faulty statement is missing from the list of suspicious statements, we assign it a rank equal to the average rank of all program statements that do not appear in the list of suspicious statements.

For example, consider a 1000-statement program. If a FL technique ranks 900 statements, but misses the faulty statement, that statement is assigned a rank of 950, which is the expected rank of that statement, if the remaining 100 statements were appended to the ranking in arbitrary order.

6) *Multiple defects:* Large real-world programs, like those in Defects4J, almost always contain multiple defects coexisting with each other. However, no action is needed to correct for this when performing fault localization, as long as the failing tests only reveal one of these defects (as is the case in Defects4J).

III. SUBJECTS OF INVESTIGATION

A. Fault localization techniques

This paper evaluates 2 families of fault localization techniques: spectrum-based fault localization (SBFL techniques for short) [4], [20], [37], [51], which is the most studied and evaluated FL technique; and mutation-based fault localization (MBFL techniques for short), which is reported to significantly outperform SBFL techniques [36], [39]. A survey paper lists other types of fault localization techniques [52].

Most fault localization techniques, including all that we examine in this paper, yield a ranked list of program statements sorted by the suspiciousness score $S(s)$ of the statement s . A high suspiciousness score means the statement is more likely to be defective—that is, to be the root cause of the failures.

1) *Spectrum-based FL techniques:* Spectrum-based fault localization techniques [4], [20], [37], [51] depend on statement execution frequencies. The more often a statement is executed by failing tests, and the less often it is executed by passing tests, the more suspicious the statement is considered.

This paper considers 5 of the best-studied SBFL techniques [52]. In the following, let $total_{passed}$ be the number of passed test cases and $passed(s)$ be the number of those that executed statement s (similarly for $total_{failed}$ and $failed(s)$).

Tarantula ^[20] :	$S(s) = \frac{\text{failed}(s)/\text{totalfailed}}{\text{failed}(s)/\text{totalfailed} + \text{passed}(s)/\text{totalpassed}}$
Ochiai ^[3] :	$S(s) = \frac{\text{failed}(s)}{\sqrt{\text{totalfailed} \cdot (\text{failed}(s) + \text{passed}(s))}}$
Op2 ^[37] :	$S(s) = \text{failed}(s) - \frac{\text{passed}(s)}{\text{totalpassed} + 1}$
Barinel ^[5] :	$S(s) = 1 - \frac{\text{passed}(s)}{\text{passed}(s) + \text{failed}(s)}$
DStar[†] ^[51] :	$S(s) = \frac{\text{failed}(s)^*}{\text{passed}(s) + (\text{totalfailed} - \text{failed}(s))}$

[†]variable $* > 0$. We chose $* = 2$, as that value is most thoroughly explored by Wong et al. [51].

2) *Mutation-based FL techniques*: Mutation-based fault localization techniques [36], [39] extend SBFL techniques by considering not just whether a statement is executed, but whether that statement’s execution is important to the test’s success or failure—that is, whether a change to that statement changes the test outcome. The more often a statement s affects failing tests, and the less often it affects passing tests, the more suspicious the statement is considered.

The key idea of MBFL is to assign suspiciousnesses to injected mutants, based on the assumption that test cases that *kill* mutants carry diagnostic power. A test case kills a mutant if executing the test on the mutant yields a different test outcome than executing it on the original program. Our study considered two well-known MBFL techniques: MUSE [36] and Metallaxis [39]. Each one generates a set of mutants $\text{mut}(s)$ for each statement s , assigns each mutant a suspiciousness $M(m)$, and aggregates the $M(m)$ to yield a statement suspiciousness score $S(s)$.

MUSE’s ranking [36] can be obtained by setting $M(m) = \text{failed}(m) - \frac{f2p}{p2f} \cdot \text{passed}(m)$ where $\text{failed}(m)$ is the number of failing tests that passed with m inserted, and $f2p$ is the number of cases in the whole program where a mutant caused any failing test to pass. $\text{passed}(m)$ and $p2f$ are defined similarly. MUSE sets $S(s) = \text{avg}_{m \in \text{mut}(s)} M(m)$. The MUSE approach is based on the assumption that mutating faulty statements is more likely than mutating correct statements to cause failing tests to pass, and mutating correct statements is more likely than mutating faulty statements to cause passing tests to fail.

Metallaxis [39] uses the same suspiciousness formula as Ochiai: Ochiai^f (the superscript f denoting a reference to the formula rather than the SBFL technique) for the suspiciousness of each mutant:

$$M(m) = \frac{\text{failed}(m)}{\sqrt{\text{totalfailed} \cdot (\text{failed}(m) + \text{passed}(m))}}$$

where $\text{failed}(m)$ is the number of failing tests whose outcomes are changed *at all* by the insertion of m (e.g., by failing at a different point or with a different error message) and totalfailed is the number of tests that fail on the original test suite ($\text{passed}(m)$ and totalpassed are defined similarly). Note that this definition of *killing a mutant* is less restrictive than MUSE’s: whereas MUSE only considers a failing test to kill a mutant if the mutant causes the test to pass, Metallaxis detects any change in the test’s behavior. The suspiciousness

of statement s is $S(s) = \max_{m \in \text{mut}(s)} M(m)$.

Since MBFL requires running the test suite once per possible mutant, it is much more expensive than SBFL: even with the optimizations described in section X-C that reduced the runtime by more than an order of magnitude, running every test necessary to compute every MBFL technique’s score on all 3637 faults took over 100,000 CPU-hours.

3) *Implementation*: We re-implemented all the fault localization techniques using shared infrastructure. This ensures that our results reflect differences in the techniques, rather than differences in their implementations. We collected coverage data using an improved version of GZoltar [9]. We collected mutation analysis data from a tool built upon the Major mutation framework [22] (v1.2.1), using all mutation operators it offers: interchanging arithmetic/comparison operators, removing parts of compound Boolean expressions, replace expressions with constants (e.g., 0 or null), deleting statements.

B. Programs

We used the programs in the Defects4J [23] dataset (v1.1.0), which consists of 395 real faults from 6 open source projects: JFreeChart (26 faults), Google Closure compiler (133 faults), Apache Commons Lang (65 faults), Apache Commons Math (106 faults), Mockito (38 faults), and Joda-Time(27 faults). For each fault, Defects4J provides faulty and fixed program versions with a minimized change that represents the isolated bug fix. This change indicates which lines in a program are defective.

1) *Patch minimization*: Each fault in Defects4J consists of a faulty and a fixed version of a program; the difference between these two versions is the patch that a programmer wrote to fix the defect. We used both automated analysis, such as delta debugging [58], and manual analysis to minimize the patch. The result was the smallest change or patch that corrects the fault in the way the programmer intended. Examples of changes that this process removed from the patches are refactorings such as renamings, and new features that the programmer added in the same commit as a bug fix. In some cases our manual analysis made a patch larger than the minimum achievable. For example, if a patch had added a function and a call to the function, then our automated analysis would find a smaller change that just added the call to the function, treating adding the function (without calling it) as a meaning-preserving refactoring. Three authors of this paper independently minimized the patches, and agreed on a patch that preserved the spirit of the programmer’s fix.

Given a minimized patch, we used an automated analysis to obtain all removed, inserted, and changed lines, but ignoring changes to declarations without an initializer, addition and removal of compound statement delimiters (curly braces {}), annotations, and import statements. These statements do not affect the program’s algorithm or are trivial to add, and therefore a FL tool should not report them. Any other statement modified by the patch is a defective statement that a FL tool should report.

TABLE II
AVERAGE NUMBER OF TEST CASES PER PROGRAM AND PER TYPE OF FAULT.

Project	Artificial Faults			Real Faults		
	Total	Pass	Fail	Total	Pass	Fail
Chart	122	118	4	185	181	4
Closure	3187	3087	100	3351	3348	3
Lang	118	115	3	94	92	2
Math	295	286	9	172	170	2
Mockito	770	738	32	671	668	3
Time	2826	2815	11	2525	2522	3

2) *Fault-relevant classes*: To reduce CPU costs, we applied each fault localization technique only to the *fault-relevant classes*. A fault-relevant class for a defect is any class that is loaded by any fault-triggering test for that defect. This optimization is sound, and a programmer could use it with little or no effort when debugging a failure. We did not use slicing, impact analysis, or other approaches to further localize or isolate the defective code.

For each fault that we localized, we obtained the set of fault-relevant classes as follows. First, we used Defects4J's infrastructure to independently execute each fault-triggering test and monitor the class loader. This yielded a set of all loaded classes of which we retained only the project-related classes (ignoring classes from libraries and the runtime environment). This set of fault-relevant classes is a sound approximation of the set of classes that contain a defect.

C. Test suites

All investigated fault localization techniques require, as an input, at least one test case that can expose the fault. For each real fault, Defects4J provides a developer-written test suite containing at least one such fault-triggering test case. To verify that each artificial fault has at least one fault-triggering test case as well, we executed the corresponding developer-written test suite and discarded the 23% of artificial faults that were not exposed by any test case. This is on the same order as the results of a study [46] finding that 16% of mutants were undetectable, 45% of which do not change the program semantics.

Table II shows, per program, the average number of test cases that load any class containing a defective statement, and how many of them pass or fail with that defect. Artificial and real faults have similar numbers of passing and failing tests, confirming that our results are not confounded by different effective test suite sizes for real and artificial faults.

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IV. REPLICATION: ARTIFICIAL FAULTS

One goal of our work is to repeat previous evaluations of fault localization techniques on artificial faults, using shared infrastructure between all of the techniques to reflect differences

TABLE III
HOW WE SELECTED FAULTS FOR OUR REPLICATION STUDIES.

Action	# faults	
	Real	Artif.
Consider all faults from Defects4J	395	5417
Every real fault must correspond to some artificial fault	386	5417
Discard faults with deletion-only fix	358	3723
Discard undetectable artificial faults	323	3242
Impose 100,000+ hour timeout		
Final	323	3242

in the techniques, not in their implementations. This section describes the techniques and faults we studied, our methodology for assessing them, and the results of the comparison.

A. Methodology

1) Research questions:

RQ 1: Which FL techniques are significantly better than which others, on artificial faults?

RQ 2: Do the answers to RQ1 agree with previous results? (For example, “Ochiai outperforms Tarantula” [4], “Metallaxis outperforms Ochiai” [39].)

2) *Data: artificial faults*: We used the Major tool [27] to generate artificial faults, by mutating the fixed program versions in Defects4J.

In order to compare real to artificial faults, we need to determine, for each real fault, which artificial faults can be sensibly compared to it. We could have generated an artificial fault for every possible mutation of every statement in the program, but many of these artificial faults would be in parts of the program completely unrelated to the corresponding real fault, where fault localization might be easier or harder; in addition, the cost of running our experiments would be unacceptably high. Therefore, we only generated artificial faults for formerly-defective statements of the fixed program version—that is, those that would need to be modified or deleted to reintroduce the real fault.

In more detail: each real fault in Defects4J is associated with a faulty and a fixed program version. For each of these pairs of program versions, Defects4J provides a patch which, when applied to the *fixed* version, would reintroduce the real fault. We call the statements modified or deleted by this patch the *fixed statements* of the real fault. We generated artificial faults by mutating the fixed statements.

Our methodology of comparing real faults to artificial faults requires that for every real fault, there is at least one artificial fault for comparison. Overall, we discarded 37 real faults that did not fit this criterion, as shown in table III. First, we discarded 9 real faults whose fixes only deleted erroneous code, so there were no fixed statements and no artificial faults can be generated. Then, we discarded artificial faults that are not detected by any tests; we also discarded artificial faults that do not compile (e.g., because a variable is no longer definitely assigned) or cause the test suite to time out (e.g., because they introduce infinite loops). This discarded all artificial faults for

28 real faults, so we removed those 28 real faults from the study.

Some faults that do not introduce an infinite loop nonetheless take a very long time during mutation testing. We ran our experiments for about 100,000 hours, and discarded faults whose MBFL analysis had not yet completed.

The output of this process was a set of 3242 artificial faults, corresponding to 323 different real faults, each artificial fault existing in a fixed statement of the corresponding real fault and detectable by the same developer-written test suite. We computed the *EXAM* score for each artificial fault and FL technique.

3) Experimental design: We answered our research questions through the following analyses:

RQ 1: Which FL techniques are significantly better than which others, on artificial faults? We used three independent, complementary evaluation metrics to rank FL techniques from best to worst:

- 1) mean *EXAM* score across all artificial faults.
- 2) tournament ranking: comparing the sets of *EXAM* scores of each pair of techniques, awarding 1 point to the winner if it is statistically significantly better, and ranking by number of points.
- 3) mean FLT rank: using each fault to rank the techniques from 1 to 7, and averaging across all artificial faults. “FLT” stands for “fault localization technique”.

RQ 2: Do the answers to RQ1 agree with previous results? For each pair of techniques compared by prior work (table I), we determined whether the two techniques’ distributions of *EXAM* scores are significantly different.

For all statistical comparisons between any two techniques in this paper, we performed a paired t-test for two reasons. First, our experiments have a matched pairs design—fault localization results are grouped per defect. Second, while the exam scores are not normally distributed, the differences between the exam scores of any two techniques are close to being normally distributed. Given that we have a large sample size and no serious violation of the normality assumption, we chose the t-test for its statistical power.

B. Results

1) Best FL technique on artificial faults: The left-hand columns in table IV show the FL technique rankings produced by our three metrics. According to our tournament ranking, Metallaxis is the best technique on artificial faults, being statistically significantly better than all other techniques.

All three metrics we used are perfectly consistent with each other, except that MUSE does best by mean FLT rank and worst by the other two metrics. This is because its distribution of scores is bimodal: as fig. 2 shows, although it usually does better than other techniques, it often does much worse. Whether it is better or worse is tightly correlated with whether a fault is caused by a “reversible” mutant (a mutant that can be canceled by a second mutant, such as $a \& b \rightarrow a \mid b$, but not $a \& b \rightarrow \text{true}$). Recall that MUSE assumes that mutating

TABLE IV
FAULT LOCALIZATION TECHNIQUES SORTED BY AVERAGE PERFORMANCE.

Technique	Artificial Faults		Technique	Real Faults	
	EXAM	# Worse		EXAM	# Worse
Metallaxis	0.0449	6	DStar	0.0404	4
Op2	0.0533	5	Ochiai	0.0405	4
DStar	0.0544	4	Barinel	0.0416	3
Ochiai	0.0548	3	Tarantula	0.0429	2
Barinel	0.0596	2	Op2	0.0476	2
Tarantula	0.0602	1	Metallaxis	0.0753	1
MUSE	0.0787	0	MUSE	0.2061	0

(a) Techniques sorted by mean *EXAM* score or tournament ranking.

Technique	Artificial Faults		Technique	Real Faults	
	Technique	FLT rank		Technique	FLT rank
MUSE	3.05	Metallaxis	3.57		
Metallaxis	3.08	Op2	3.73		
Op2	3.68	DStar	3.73		
DStar	3.91	Ochiai	3.78		
Ochiai	4.04	Barinel	4.14		
Barinel	5.12	Tarantula	4.16		
Tarantula	5.12	MUSE	4.89		

(b) Techniques sorted by mean FLT rank

a faulty statement will sometimes cause a failing test to pass. This is why it does well on artificial faults caused by reversible mutants: there exists a mutant which will repair the fault, thus causing all failing tests to pass. This mutant will be located in the faulty statement, and it will achieve the maximum possible suspiciousness, putting that statement near the top of the ranking and explaining MUSE’s excellent performance on the majority of artificial faults. Irreversible mutants are responsible for the cluster of large scores in fig. 2, explaining why MUSE is best by mean FLT rank but worst by mean *EXAM* score.

MUSE’s success is so tightly connected to the fault’s reversibility because of its very restrictive definition for whether a failing test kills a mutant (the mutant must cause the test to pass). This criterion is very rarely met, *except* for when a mutant reverses an artificial fault. If MUSE used a different interaction (kill)-definition, it would lose its pinpoint accuracy on reversible faults, but it would also have fewer large outlier scores on irreversible faults, as shown in fig. 4.

As shown by the peaks for the dotted lines in fig. 2, MBFL techniques very often rank the artificially-faulty statement in the top 5. One reason for this is that many artificial faults we generate are caused by “reversible” mutants: mutants that can be exactly canceled by applying a second mutant (e.g., $a+b \rightarrow a-b \rightarrow a+b$). Reversible artificial faults guarantee that MBFL will consider some mutant in the faulty statement that fixes every failing test and that receives a very high suspiciousness score.

2) Agreement with previous results: For each of the 10 pairs of techniques that the prior work in table I has compared, we performed a two-tailed t-test comparing the two techniques’ scores for artificial faults. The left column of table V shows the results of prior comparisons, and the middle columns show our results. Notable features include:

Small effect sizes. All 10 pairs of techniques have *statistically* significant differences: the “agree?” column of table V

is unparenthesized. However, the practical differences (that is, effect sizes) are all small or negligible: the “d” column is parenthesized. All spectrum-based techniques (except Tarantula) are nearly indistinguishable in fig. 2. We only see statistical significance because of our large number of artificial faults.

Consistency with prior SBFL-SBFL comparisons. Our results agree with all previous comparisons between SBFL techniques, except the claim that Barinel outperforms Ochiai, which our results contradict. The difference may be due to our different set of faults, or differences between our implementation and that in [5].

Disagreement with prior SBFL-MUSE comparisons. Prior comparisons found MUSE superior to SBFL techniques. Our results do not support that finding: although MUSE is better on many artificial faults, it does much worse on others. Overall, the differences are practically insignificant.

V. REPLICATION: REAL FAULTS

A. Subjects

We evaluated the same techniques, programs, and test suites as described in section III, except that instead of evaluating each technique on the 3242 artificial faults described in section IV, we evaluate them on the corresponding 323 *real* faults.

B. Methodology

Our methodology is exactly like that described in section IV-A, except evaluated on real faults, to answer:

RQ 3: Which FL techniques are significantly better than which others, on real faults?

RQ 4: Do the answers to RQ3 agree with previous results?

C. Results

1) *Best FL techniques on real faults:* The right-hand columns in the top part of table IV show the FL technique rankings for real faults produced by either the mean *EXAM* score metric or the tournament ranking metric. The mean FLT rank (bottom part of table IV) gives almost the same ranking, except that Metallaxis ranks first instead of nearly last. Metallaxis usually has slightly higher scores than any other technique (as shown in fig. 2), giving it a good FLT rank, but it also has more extreme outliers than SBFL techniques, greatly damaging its mean *EXAM* score.

2) *Agreement with previous results:* The right-hand columns of table V compare our results on real faults to the results of the studies we replicated. Notably:

Insignificant differences between SBFL techniques. All effect sizes are negligible: column “d” is italicized.

Practical significance: MUSE performs poorly. The only practically significant differences show that MUSE performs poorly on real faults (see fig. 2). This is due to almost no real faults being reversible by a single mutant (see section IV-B1).

Independence of debugging scenario. Our conclusions hold in all debugging scenarios, as shown in table XVII in the appendix.

D. Comparison to artificial faults

The most important feature of tables IV and V is that *there is no significant relationship between the results for real and artificial faults*. This suggests that artificial faults are not useful for the purpose of determining which FL technique is best at localizing mistakes that programmers actually make.

Another notable feature is that while Metallaxis performs best on artificial faults, it does worse than spectrum-based techniques on real faults. One reason for this may be that 10% of real-world faults involve non-mutable statements, which appear last in mutation-based techniques’ suspiciousness rankings. These outlier scores greatly degrade the technique’s mean score. On real faults, Metallaxis has the best mean FLT rank but one of the worst mean *EXAM* scores.

These findings are again independent of the debugging scenario as shown in table XVII in the appendix.

Perhaps the results are different for specific types of faults, such as single-line faults or faults of omission. Tables VI to VIII repeat the analysis of RQ1, restricted to different categories of real faults. Again, there are no statistically significant relationships between rankings on real and artificial faults, even for single-line faults—which one would expect to be the most similar to mutants—or faults of omission, on which some FL techniques might perform poorly.

E. Controlling for number of samples

Table V shows statistically significant results for artificial faults, but mostly insignificant results on real faults. It is possible that the results are insignificant because there are so few data points—there are many more artificial than real faults. To investigate this, we averaged FL techniques’ scores over the artificial faults that correspond to each single real fault, so there are only 323 datapoints for artificial faults. The results for artificial faults remained statistically significant (table XVIII), showing that having 323 data points does not prevent statistically significant results. Furthermore, the effect sizes for real faults are negligible for SBFL comparisons, and the confidence intervals are tight (table V). Artificial faults are not a good proxy for any single technique: the correlation between each technique’s performance on artificial faults and real faults is at most moderate—mostly weak or negligible table XX.

VI. EXPLORING A DESIGN SPACE

To better understand these differences in performance and their causes, we developed a design space that encompasses all of these techniques, and evaluated the techniques in that space on our overall set of 395 real faults.

A. Subjects

All 7 of the techniques described in section III-A have the same basic structure:

- 1) For each program element (i.e., statements or mutants), count the number of passing/failing tests that interact with (i.e., execute or kill) that element.

TABLE V

PREVIOUSLY-REPORTED COMPARISONS, AND OUR RESULTS FOR THOSE COMPARISONS, IN THE BEST-CASE DEBUGGING SCENARIO.

The conclusions are the same for all debugging scenarios (table XVII). Emphasis on whether our study *agrees* indicates p-value: $p < 0.01$, $p < 0.05$, ($p \geq 0.05$). Emphasis on Cohen's d indicates effect size: **large**, medium, (small), (*negligible*). The column “95% CI” gives the confidence interval for the difference in means. The column “(b – eq – w)” gives the counts for: per defect, was the winner better, equal to, or worse compared to the loser, ignoring the magnitude of the difference.

Previous comparisons Winner > loser	Our study on artificial faults				Our study on real faults			
	agree?	d (eff. size)	95% CI	(b – eq – w)	agree?	d (eff. size)	95% CI	(b – eq – w)
Ochiai > Tarantula [30], [31], [37], [51], [57]	yes	(-0.24)	[-0.006, -0.005]	(1443–1796–3)	(insig.)	(-0.1)	[-0.004, 0.000]	(75–236–12)
Barinel > Ochiai [5]	no	(0.26)	[0.004, 0.005]	(3–1799–1440)	(insig.)	(0.1)	[-0.000, 0.003]	(12–237–74)
Barinel > Tarantula [5]	yes	(-0.05)	[-0.001, -0.000]	(9–3233–0)	(insig.)	(-0.06)	[-0.003, 0.001]	(1–322–0)
Op2 > Ochiai [37]	yes	(-0.1)	[-0.002, -0.001]	(597–2627–18)	no	(0.14)	[0.002, 0.013]	(65–226–32)
Op2 > Tarantula [36], [37]	yes	(-0.24)	[-0.008, -0.006]	(1522–1702–18)	(insig.)	(0.09)	[-0.001, 0.011]	(81–208–34)
DStar > Ochiai [30], [51]	yes	(-0.11)	[-0.001, -0.000]	(342–2898–2)	(insig.)	(-0.02)	[-0.001, 0.001]	(29–283–11)
DStar > Tarantula [21], [30], [51]	yes	(-0.24)	[-0.007, -0.005]	(1454–1785–3)	(insig.)	(-0.1)	[-0.005, 0.000]	(75–233–15)
Metallaxis > Ochiai [39]	yes	(-0.05)	[-0.017, -0.002]	(2072–240–930)	no	(0.2)	[0.013, 0.043]	(173–19–131)
MUSE > Op2 [36]	no	(0.11)	[0.017, 0.033]	(2030–132–1080)	no	0.78	[0.131, 0.173]	(119–3–201)
MUSE > Tarantula [36]	no	(0.08)	[0.011, 0.026]	(2254–81–907)	no	0.84	[0.137, 0.178]	(116–2–205)

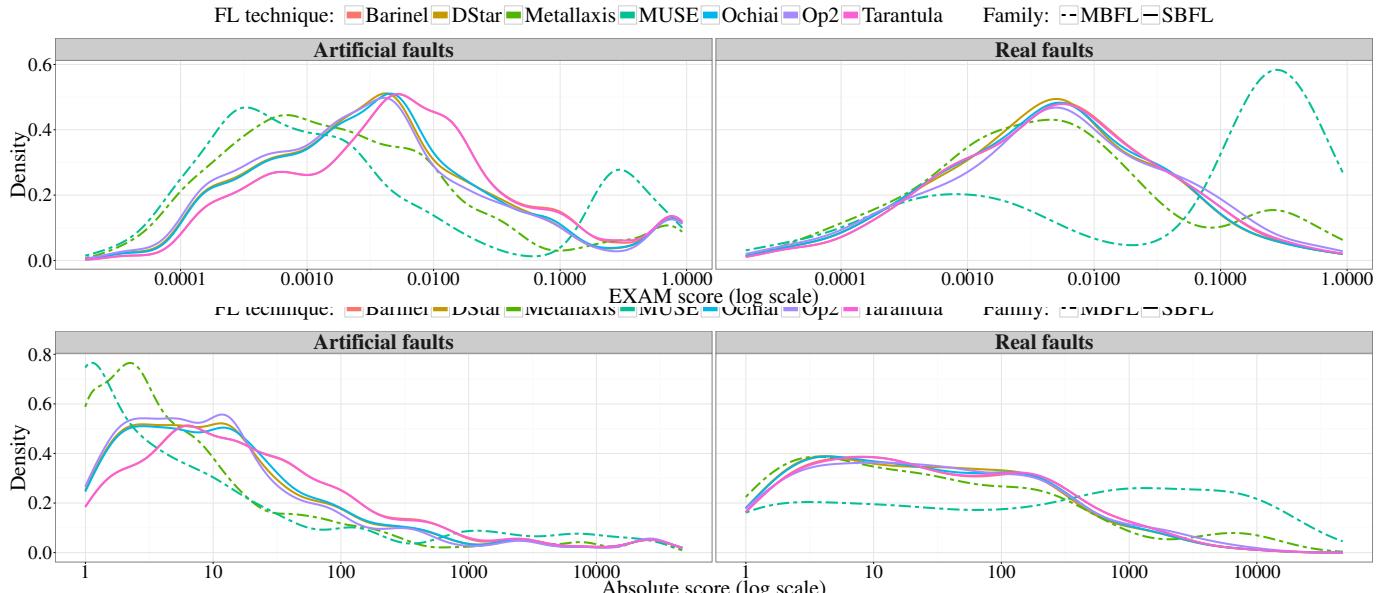


Fig. 2. Distributions of *EXAM* and absolute scores for all FL techniques, considering the best-case debugging scenario and artificial vs. real faults. The absolute score is the first location of any defective statement in the suspiciousness ranking of program statements, computed by a fault localization technique.

- 2) Calculate a suspiciousness for each element, by applying a formula to the numbers of passing/failing tests that interact.
- 3) If necessary, group those elements by statement, and aggregate across the elements’ suspiciousnesses to compute the statement’s suspiciousness.
- 4) Rank statements by their suspiciousness.

We developed a taxonomy for describing any of these techniques in terms of 4 different parameters:

Formula: the formula used to compute elements’ suspiciousness values (e.g., Ochiai^f)

Total Definition: the method for weighting passing/failing test interactions in the formula

Interaction Definition: what it means for a test to *interact* with an element (i.e., coverage for SBFL, killing for MBFL)

Aggregation Definition: for MBFL, the way of aggregating elements’ suspiciousness by statement (e.g., max, average)

These parameters are described in more detail below. For

SBFL techniques, the “elements” are simply statements. A test interacts with a statement by executing it, and no aggregation of elements by statement is necessary, so the only two relevant parameters are formula and total definition.

The following subsections detail the possible values for each of these parameters. By taking all sensible combinations of them, we arrive at a design space containing 156 techniques.

1) *Formula:* We consider the formulas for the SBFL techniques Tarantula, Ochiai, DStar, Barinel, and Op2, as well as the formula used by MUSE, which can be cast as

$$S(s) = \text{failed}(s) - \frac{\text{totalfailed}}{\text{totalpassed}} \cdot \text{passed}(s).$$

When combined with the appropriate values of the other parameters, this formula produces MUSE’s statement-ranking.

2) *Total definition:* Almost all of the prior FL techniques make use of *totalpassed* and *totalfailed* in their suspiciousness formulas, representing the numbers of passing/failing tests. MUSE, though (recall from section III-A2), instead refers to *p2f* and *f2p*, representing the number of *mutants killed* by

TABLE VI

TECHNIQUES SORTED BY VARIOUS METRICS CONSIDERING ONLY SINGLE-LINE FAULTS THAT WERE NOT FAULTS OF OMISSION, AND ON THEIR CORRESPONDING ARTIFICIAL FAULTS.

Artificial Faults		Real Faults	
Technique	EXAM Score	Technique	EXAM Score
Metallaxis	0.0521	DStar	0.0518
Op2	0.0909	Ochiai	0.0519
DStar	0.0927	Barinel	0.0532
Ochiai	0.0936	Op2	0.0542
Barinel	0.1005	Tarantula	0.0589
Tarantula	0.1005	Metallaxis	0.1149
MUSE	0.1040	MUSE	0.2387

(a) Techniques sorted by mean EXAM score

Artificial Faults		Real Faults	
Technique	# Worse	Technique	# Worse
Metallaxis	6	Ochiai	2
DStar	3	Barinel	2
Op2	3	DStar	2
Ochiai	2	Op2	2
Barinel	0	Tarantula	2
MUSE	0	Metallaxis	1
Tarantula	0	MUSE	0

(b) Techniques sorted by tournament ranking over mean EXAM scores.
These rankings are uncorrelated because $p = 0.92$.

Artificial Faults		Real Faults	
Technique	FLT rank	Technique	FLT rank
Metallaxis	2.73	Metallaxis	3.64
MUSE	3.06	Op2	3.78
Op2	3.70	DStar	3.81
DStar	4.02	Ochiai	3.88
Ochiai	4.20	Barinel	4.07
Barinel	5.15	Tarantula	4.16
Tarantula	5.15	MUSE	4.66

(c) Techniques sorted by mean rank among FL techniques

passing/failing tests. Motivated by the resemblance between these quantities, we introduced a parameter that determines whether *totalpassed*, in the FL technique’s formula, refers to the number of *tests* or the number of *elements interacted with* by the tests (and similarly for *totalfailed*).

3) *Interaction definition*: For SBFL there is one clear definition for whether a test interacts with a statement: coverage, or executing the statement. For MBFL, the definition of whether a test “kills” a mutant is not firmly established. MUSE requires that the mutant change whether the test passes or fails, while Metallaxis merely requires that the mutant cause any change to the test’s output (for example, change the message of an exception thrown by a failing test). We used the following framework to describe the spectrum of possible definitions.

A test kills a mutant if it changes the test outcome—more specifically, if it changes the outcome’s *equivalence class*. We give 6 ways to define the equivalence classes. All of them define one class for “pass”, one class for “timeout”, one class for “JVM crash”, and several classes for “exception” (including *AssertionError*). The 6 definitions differ in how they partition exceptions:

- 1) **exact**: exceptions with the exact same stack trace are equivalent;

TABLE VII

TECHNIQUES SORTED BY VARIOUS METRICS CONSIDERING ONLY MULTI-LINE FAULTS THAT INCLUDED FAULTS OF OMISSION, AND ON THEIR CORRESPONDING ARTIFICIAL FAULTS.

Artificial Faults		Real Faults	
Technique	EXAM Score	Technique	EXAM Score
Metallaxis	0.0444	Ochiai	0.0310
Op2	0.0496	Barinel	0.0312
DStar	0.0505	Tarantula	0.0312
Ochiai	0.0508	DStar	0.0316
Barinel	0.0549	Op2	0.0433
Tarantula	0.0549	Metallaxis	0.0496
MUSE	0.0778	MUSE	0.1885

(a) Techniques sorted by mean EXAM score

Artificial Faults		Real Faults	
Technique	# Worse	Technique	# Worse
Op2	5	Ochiai	3
DStar	4	Barinel	3
Ochiai	3	DStar	3
Metallaxis	3	Tarantula	3
Barinel	1	Op2	1
Tarantula	1	Metallaxis	1
MUSE	0	MUSE	0

(b) Techniques sorted by tournament ranking over mean EXAM scores.
These rankings are uncorrelated because $p = 0.79$.

Artificial Faults		Real Faults	
Technique	FLT rank	Technique	FLT rank
MUSE	3.15	Metallaxis	3.49
Metallaxis	3.25	DStar	3.69
Op2	3.70	Ochiai	3.71
DStar	3.86	Op2	3.72
Ochiai	3.97	Barinel	4.17
Barinel	5.04	Tarantula	4.17
Tarantula	5.04	MUSE	5.06

(c) Techniques sorted by mean rank among FL techniques

- 2) **type+fields+location**: exceptions with the same type, message, and location are equivalent;
- 3) **type+fields**: exceptions with the same type and same message are equivalent;
- 4) **type**: exceptions with the same type are equivalent;
- 5) **all**: all exceptions are equivalent;
- 6) **passfail**: all exceptions are equivalent to one another and to the “time out” and “crash” classes (so there are only two possible equivalence classes: “pass” and “fail”).

Metallaxis uses the “exact” definition. MUSE uses the “passfail” definition.

4) *Aggregation definition*: MBFL computes an aggregate statement suspiciousness $S(s)$ from the suspiciousnesses of individual mutants by taking either the average (like Metallaxis) or the maximum (like MUSE). Unmutable statements are not assigned any suspiciousness, and therefore do not appear in the technique’s ranking. (Approximately 10% of Defects4J’s faults contain at least one unmutable faulty statement. This causes MBFL to do quite poorly in the worst-case debugging scenario, when its goal is to find the position of *all* faulty statements.)

B. Methodology

RQ 5: Which technique in this design space performs best on real faults? For each of our evaluation metrics (EXAM score,

TABLE VIII

TECHNIQUES SORTED BY VARIOUS METRICS CONSIDERING ONLY MULTI-LINE FAULTS THAT DID NOT INCLUDE FAULTS OF OMISSION, AND ON THEIR CORRESPONDING ARTIFICIAL FAULTS.

Artificial Faults		Real Faults	
Technique	EXAM Score	Technique	EXAM Score
Op2	0.0280	DStar	0.0281
DStar	0.0291	Ochiai	0.0304
Ochiai	0.0297	Op2	0.0336
Barinel	0.0368	Barinel	0.0340
Metallaxis	0.0391	Tarantula	0.0340
Tarantula	0.0420	Metallaxis	0.0742
MUSE	0.0633	MUSE	0.1768

(a) Techniques sorted by mean EXAM score

Artificial Faults		Real Faults	
Technique	# Worse	Technique	# Worse
Op2	5	DStar	2
DStar	4	Ochiai	1
Ochiai	3	Barinel	1
Barinel	2	Op2	1
Tarantula	1	Tarantula	1
Metallaxis	1	Metallaxis	1
MUSE	0	MUSE	0

(b) Techniques sorted by tournament ranking over mean EXAM scores.
These rankings are uncorrelated because $p = 0.10$.

Artificial Faults		Real Faults	
Technique	FLT rank	Technique	FLT rank
Metallaxis	2.53	DStar	3.63
MUSE	2.83	Ochiai	3.75
Op2	3.50	Op2	3.75
DStar	3.90	Metallaxis	3.95
Ochiai	4.15	Barinel	4.14
Barinel	5.52	Tarantula	4.14
Tarantula	5.57	MUSE	4.63

(c) Techniques sorted by mean FLT rank

FLT rank) and debugging scenarios (best-case, average-case, worst-case), we identified the technique that performed best, averaged across all 395 real faults. To quantify how often these techniques significantly outperform others, we performed pairwise comparisons between them and each of the other 155 techniques, using a paired t-test.

RQ 6: What are the most significant design decisions for a FL technique? We performed an analysis of variance to determine the influence of the 4 design space parameters, the debugging scenario, and the defect on the EXAM score. In other words, we computed how much variance in the EXAM score is explained by each factor.

C. Results

1) *What is the best fault localization technique?*: First, here are the results when judging by the mean EXAM score. (1) For the best-case debugging scenario, the DStar technique is best, and its score is almost twice as good as the best MBFL technique, which closely resembles Metallaxis (see table IX). (2) For the worst-case debugging scenario, Barinel performs best, when instantiated with the “number of statements covered” definition of *totalpassed* and *totalfailed*. (3) For the average-case debugging scenario, Ochiai performs best,

TABLE IX
BEST FL TECHNIQUES PER FAMILY ACCORDING TO MEAN EXAM SCORE.
THE FIRST COLUMN IS RANK AMONG THE 156 TECHNIQUES.

Family	Formula	Total def.	Interact. def.	Agg. def	EXAM score
<i>best-case debugging scenario (localize any defective statement)</i>					
1	SBFL	DStar ^f	tests	–	0.040
13	MBFL	Ochiai ^f	elements	exact	0.078
<i>worst-case debugging scenario (localize all defective statements)</i>					
1	SBFL	Barinel ^f	elements	–	0.191
13	MBFL	Ochiai ^f	elements	exact	0.245
<i>average-case debugging scenario (localize 50% of defective statements)</i>					
1	SBFL	Ochiai ^f	elements	–	0.088
13	MBFL	DStar ^f	tests	exact	0.129

TABLE X
BEST FL TECHNIQUES PER FAMILY ACCORDING TO THE MEAN FLT RANK.

Family	Formula	Total def.	Interact. def.	Agg. def.	Rank
<i>best-case debugging scenario (localize any defective statement)</i>					
1	MBFL	DStar ^f	tests	type	avg
29	SBFL	DStar ^f	tests	–	77.9
<i>worst-case debugging scenario (localize all defective statements)</i>					
1	MBFL	MUSE ^f	elements	exact	max
67	SBFL	DStar ^f	tests	–	82.9
<i>average-case debugging scenario (localize 50% of defective statements)</i>					
1	MBFL	MUSE ^f	elements	exact	max
10	SBFL	DStar ^f	tests	–	74.2

instantiated the same way. As table XI shows, in every debugging scenario, all 12 SBFL techniques are better than the best MBFL technique, which is itself statistically significantly better than about 80% of the design space.

However, judged by mean FLT rank (shown in table X), this reverses, and many MBFL techniques are better than any SBFL technique. As seen in table XI, the best MBFL technique by FLT rank for two debugging scenarios uses MUSE’s formula and total-definition, but Metallaxis’s aggregation and interaction (kill)-definition. (Recall from section IV-B that MUSE’s kill-definition tied its performance to fault reversibility. Using a different kill-definition damages its performance on reversible faults, but as shown in fig. 4, makes it much better on real faults.)

As discussed elsewhere, we consider the EXAM score and the best-case debugging scenario to be the best approximation to real use cases.

DStar is the best fault localization technique in the design space. However, it is statistically indistinguishable from four other SBFL techniques, including Ochiai and Barinel.

2) *Which parameters matter in the design of a FL technique?*: We analyzed the influence of the 4 different parameters on the EXAM score. Table XII shows the results, indicating that all factors (including all FL technique parameters, as well as the defect and debugging scenario) have a statistically significant effect on the EXAM score.

It is unsurprising that most of the variance in scores (“sum of squares” column) is accounted for by *which defect* is being localized: some faults are easy to localize and some are difficult.

TABLE XI

PAIRWISE COMPARISON OF THE BEST TECHNIQUE PER EVALUATION METRIC WITH ALL OTHER TECHNIQUES IN THE DESIGN SPACE. “# BETTER THAN” GIVES THE NUMBER OF COMPARISONS FOR WHICH THE BEST TECHNIQUE IS SIGNIFICANTLY BETTER, AND “ \bar{d} ” GIVES THE AVERAGE EFFECT SIZE.

Evaluation metric	Best FL technique			# Better than	\bar{d}
	Family	Formula	Total	Inter. def.	Agg. def.
best-case debugging scenario (localize any defective statement)					
Mean EXAM score	SBFL	DStar ^f	tests	–	151/155 –0.47
Mean FLT rank	MBFL	DStar ^f	tests	type	128/155 –0.18
worst-case debugging scenario (localize all defective statements)					
Mean EXAM score	SBFL	Barinel ^f	elements	–	149/155 –0.42
Mean FLT rank	MBFL	MUSE ^f	elements	exact	135/155 –0.22
average-case debugging scenario (localize 50% of defective statements)					
Mean EXAM score	SBFL	Ochiai ^f	elements	–	149/155 –0.47
Mean FLT rank	MBFL	MUSE ^f	elements	exact	146/155 –0.25

TABLE XII

ANOVA ANALYSIS OF THE EFFECT OF ALL FACTORS ON THE EXAM SCORE FOR REAL FAULTS. R^2 GIVES THE COEFFICIENT OF DETERMINATION.

Factor	Deg. of freedom	Sum of squares	F-value	p
<i>sbfl</i> ($R^2 = 0.65$)				
Defect	394	387	58	<0.05
Debugging scenario	2	57.9	1703	<0.05
Formula	5	0.374	4	<0.05
Total definition	1	0.00623	0	(insig.)
<i>mbfl</i> ($R^2 = 0.67$)				
Defect	394	5508	725	<0.05
Debugging scenario	2	718	18614	<0.05
Interaction definition	5	324	3357	<0.05
Formula	5	20.4	211	<0.05
Aggregation definition	1	1.33	69	<0.05
Total definition	1	0.145	8	<0.05
<i>sbfl + mbfl</i> ($R^2 = 0.64$)				
Defect	394	5595	686	<0.05
Debugging scenario	2	776	18734	<0.05
Family	12	426	1716	<0.05
Formula	5	20.3	196	<0.05
Total definition	1	0.15	7	<0.05

Interestingly, although prior studies have mostly focused on the formula and neglected other factors, we find that the formula has relatively little effect on how well a FL technique performs. The choice of the formula accounts for no more than 2% of the non-defect variation in the EXAM scores (see sum-of-squares column). Furthermore, a post-hoc Tukey test (table XIII) showed that the differences between most formulas are insignificant for SBFL techniques, and often for MBFL techniques as well.

All studied parameters have a statistically significant effect on the EXAM score, but the only FL technique parameters with a practically significant effect are *family* (SBFL vs. MBFL) and *interaction (kill) definition* (for MBFL only).

VII. NEW TECHNIQUES

Beyond the quantitative results discussed so far, our studies exposed three limitations of MBFL techniques. (i) MBFL

TABLE XIII

PAIRWISE COMPARISON (TUKEY POST-HOC TEST) OF ALL *Formulas*. FOR EACH PAIR, THE P VALUE INDICATES WHETHER THE CHOICE OF THE FORMULA SIGNIFICANTLY AFFECTS THE EXAM SCORE FOR REAL FAULTS.

Formula 1	Formula 2	p (sbfl)	p (mbfl)	p (sbfl+mbfl)
DStar ^f	Barinel ^f	(insig.)	<0.01	<0.01
MUSE ^f	Barinel ^f	<0.05	<0.01	<0.01
Ochiai ^f	Barinel ^f	(insig.)	(insig.)	(insig.)
Op2 ^f	Barinel ^f	<0.05	<0.01	<0.01
Tarantula ^f	Barinel ^f	(insig.)	(insig.)	(insig.)
MUSE ^f	DStar ^f	(insig.)	<0.01	<0.01
Ochiai ^f	DStar ^f	(insig.)	<0.01	<0.01
Op2 ^f	DStar ^f	(insig.)	<0.01	<0.01
Tarantula ^f	DStar ^f	(insig.)	(insig.)	(insig.)
Ochiai ^f	MUSE ^f	<0.05	<0.01	<0.01
Op2 ^f	MUSE ^f	(insig.)	(insig.)	(insig.)
Tarantula ^f	MUSE ^f	<0.05	<0.01	<0.01
Op2 ^f	Ochiai ^f	<0.05	<0.01	<0.01
Tarantula ^f	Ochiai ^f	(insig.)	(insig.)	(insig.)
Tarantula ^f	Op2 ^f	(insig.)	<0.01	<0.01

techniques perform poorly on defects that involve unmutable statements. (ii) MBFL techniques perform poorly when some mutants are covered but not killed. (iii) The run time of MBFL techniques is several orders of magnitude larger than for SBFL techniques, because mutation analysis requires running the entire test suite many times (once per mutant).

This section describes three approaches we explored with the aim to address these limitations and to design better fault localization techniques:

- 1) **MCBFL**: To address the limitation of covered yet not killed mutants, we explore an improved MBFL technique that uses mutation coverage information in addition to mutation kill information.
- 2) **MCBFL-hybrid**: To address the limitation of unmutable statements, we explore a family of hybrid techniques that combine MCBFL with SBFL to further improve MCBFL.
- 3) **MRSBFL**: To address the scalability issue of MBFL techniques, we explore a faster MBFL technique that uses only mutation coverage information.

A. MCBFL

One contributor to the poor performance of MBFL techniques on real faults is that they consider only which tests *kill* which mutants, and disregard coverage information. For example, on Defects4J’s bug Chart-1, one mutant changes the faulty statement from `if (this.dataset != null) ... to if (true) ...` —this mutant is covered (executed) by the sole failing test, but not killed by it. Intuitively, a mutant covered by a failing test should be more suspicious than a mutant that is not even executed.

To study this intuition, we introduced a new family of techniques, which operate in exactly the same way as MBFL techniques, except that the suspiciousness of each mutant is increased if it is covered by failing tests. We identified three ways to accomplish this:

- 1) **numerator** (small increase): if a mutant is covered by any

- failing test, increase its suspiciousness slightly by incrementing (or decrementing) the numerator of the fraction in the suspiciousness formula. This typically makes such mutants very slightly more suspicious, thus differentiating between mutants that are completely irrelevant to failing tests and mutants that are covered but not killed by failing tests.
- 2) **constant** (large increase): if a mutant is covered by any failing test, increase its suspiciousness by 1. For the formulas we consider, 1 is a fairly substantial increase in suspiciousness: this will typically ensure that every mutant covered by a failing test is more suspicious than any mutant not covered by a failing test.
 - 3) **mirror** (variable increase): recall that in MBFL, each mutant’s suspiciousness is computed by applying one of the formulas in section III-A1 to the numbers of passing/failing tests that kill it. The mirror technique applies the same formula also to the numbers of passing/failing tests that *cover* the mutant, and calculates the overall suspiciousness as the sum of the formula applied to kill and coverage information.

We applied each of these three modifications to the MBFL technique with the best mean FLT rank, to generate three variants of a new technique that we call “mutant-and-coverage-based fault localization” (MCBFL) technique.

1) *Results*: We evaluated the three MCBFL techniques on Defects4J’s real defects, using the same methodology as in section VI. The **mirror** technique always outperformed the other two MCBFL techniques.

Tables XIV and XV show the relative performances of the best technique in each family (SBFL, MBFL, MCBFL, and the other techniques introduced in section VII). The best MCBFL technique significantly outperforms the MBFL techniques. Moreover, the best MCBFL technique is better than SBFL judging by mean FLT rank, but slightly worse in terms of mean EXAM score. This suggests that MCBFL techniques are better than spectrum-based ones at localizing most defects, but that they also have more outlier scores, causing them to do worse on average. If there was a way to improve the MCBFL techniques on those outliers, the resultant technique would likely outperform all other techniques in our design space.

B. MCBFL-hybrid

This section describes three hybrid approaches that aim to mitigate outlier scores, which drag down the effectiveness of mutation-based fault localization techniques.

One cause of outliers for MCBFL techniques is unmutable statements. Since MCBFL, like MBFL, assigns suspiciousness values to statements by aggregating the suspiciousness values of their mutants, it assigns no suspiciousness score to unmutable statements, so those statements appear at the end of the technique’s statement-ranking as described in section II-B. Therefore, when only unmutable statements are faulty, MCBFL techniques perform exceptionally badly. Note that unmutable statements appear at the end, not because the MCBFL technique ranks them as very unsuspicious, but

because the technique simply *has no opinion* about them. By using a different technique to assign suspiciousness values to those statements, we aim to make better guesses at how they should be ranked.

1) *Failover*: A failover technique assigns a suspiciousness to every statement, using:

- 1) If possible (i.e., if the statement is mutable): the technique with the best mean FLT rank (i.e., MCBFL);
- 2) otherwise: the technique with the best mean EXAM score (i.e., DStar).

2) *Suspiciousness-averaging and maxing*: Another approach to improving MCBFL’s scores for outliers is to, for each statement, combine the suspiciousness assigned by MCBFL with that assigned by SBFL. Assuming that both component techniques *usually* assign high suspiciousness to faulty statements, and outliers occur when they accidentally assign very low suspiciousness to those statements, combining the two suspiciousness values should mitigate the damage done by those mistakes. (Missing suspiciousness scores, such as for MCBFL on unmutable statements, are taken to be 0.)

We experimented with two methods of combining the suspiciousness scores: averaging and taking the maximum.

3) *Results*: As evidenced by tables XIV and XV, the MCBFL-hybrid-failover technique does somewhat better than the best MCBFL technique, as measured by mean EXAM score. It does somewhat worse as measured by mean FLT rank, which is not surprising: it is based on the MCBFL technique with the best mean FLT rank, and adding SBFL was intended to improve the *mean EXAM score*, without regard for the FLT rank. The mean rank most likely gets worse because, even though the failover SBFL technique raises faulty unmutable statements in the ranking produced by the MCBFL technique, it raises non-faulty unmutable statements as well: the enormous improvement for a few bugs comes at the cost of very slightly worse scores on many more.

The other two hybrid techniques are displayed as *MCBFL-hybrid-avg* and *MCBFL-hybrid-max* in tables XIV and XV. MCBFL-hybrid-avg is better by every metric than the best SBFL technique.

C. MRSBFL

Mutation analysis is computationally expensive (see also discussion in section X-C). We therefore created less expensive mutant-based techniques by substituting mutant *coverage* information for the mutant *kill* information used by MBFL techniques: these “mutant-resolution spectrum-based” techniques (MRSBFL techniques) require only one run of the test suite, and therefore are comparable in execution time to the SBFL techniques.

1) *Results*: We evaluated MRSBFL versions of the best MBFL technique the other three experimental techniques. As table XIV shows, these techniques achieve nearly the same scores as their MCBFL-based equivalents, and at substantially lower computational cost.

TABLE XIV
BEST FL TECHNIQUES PER FAMILY ACCORDING TO MEAN EXAM SCORE.

Family	Formula	Total def.	Interact. def.	Agg. def.	EXAM score	
best-case debugging scenario (localize any defective statement)						
1	MCBFL-hybrid-avg	–	–	–	0.034 273	
2	MCBFL-hybrid-max	–	–	–	0.034 652	
3	MRSBFL-hybrid-max	–	–	–	0.035 594	
4	MRSBFL-hybrid-avg	–	–	–	0.036 099	
5	MCBFL-hybrid-failover	–	–	–	0.039 445	
6	SBFL	DStar ^f	tests	–	0.040 031	
11	MRSBFL-hybrid-failover	–	–	–	0.041 284	
19	MCBFL	–	–	–	0.057 708	
20	MRSBFL	–	–	–	0.059 736	
21	MBFL	Ochiai ^f	elements	exact	max	0.077 750
worst-case debugging scenario (localize all defective statements)						
1	MRSBFL-hybrid-max	–	–	–	0.182 354	
2	MCBFL-hybrid-max	–	–	–	0.182 442	
3	MCBFL-hybrid-avg	–	–	–	0.182 685	
4	MRSBFL-hybrid-avg	–	–	–	0.183 279	
5	MRSBFL-hybrid-failover	–	–	–	0.184 189	
6	MCBFL-hybrid-failover	–	–	–	0.184 376	
7	SBFL	Barinel ^f	elements	–	0.190 808	
19	MCBFL	–	–	–	0.213 465	
20	MRSBFL	–	–	–	0.213 583	
21	MBFL	Ochiai ^f	elements	exact	max	0.244 846
average-case debugging scenario (localize 50% of defective statements)						
1	MCBFL-hybrid-avg	–	–	–	0.082 335	
2	MCBFL-hybrid-max	–	–	–	0.082 912	
3	MRSBFL-hybrid-max	–	–	–	0.083 747	
4	MRSBFL-hybrid-avg	–	–	–	0.084 281	
5	MCBFL-hybrid-failover	–	–	–	0.084 719	
6	MRSBFL-hybrid-failover	–	–	–	0.086 221	
7	SBFL	Ochiai ^f	elements	–	0.087 853	
19	MCBFL	–	–	–	0.104 059	
20	MRSBFL	–	–	–	0.106 036	
21	MBFL	DStar ^f	tests	exact	max	0.128 669

TABLE XV
BEST FL TECHNIQUES PER FAMILY ACCORDING TO MEAN FLT RANK.

Family	Formula	Total def.	Interact. def.	Agg. def.	Rank	
best-case debugging scenario (localize any defective statement)						
1	MCBFL	–	–	–	64.9	
2	MCBFL-hybrid-avg	–	–	–	66.3	
3	MRSBFL	–	–	–	71.3	
4	MRSBFL-hybrid-avg	–	–	–	71.6	
5	MCBFL-hybrid-failover	–	–	–	71.8	
6	MBFL	DStar ^f	tests	type	avg	72.2
32	MCBFL-hybrid-max	–	–	–	77.0	
35	SBFL	DStar ^f	tests	–	–	77.9
36	MRSBFL-hybrid-max	–	–	–	78.0	
37	MRSBFL-hybrid-failover	–	–	–	78.2	
worst-case debugging scenario (localize all defective statements)						
1	MCBFL	–	–	–	69.8	
2	MBFL	MUSE ^f	elements	exact	max	71.1
6	MRSBFL	–	–	–	71.7	
35	MCBFL-hybrid-avg	–	–	–	78.7	
48	MRSBFL-hybrid-avg	–	–	–	80.6	
60	MCBFL-hybrid-failover	–	–	–	82.1	
72	SBFL	DStar ^f	tests	–	–	82.9
90	MRSBFL-hybrid-failover	–	–	–	83.9	
106	MCBFL-hybrid-max	–	–	–	84.4	
107	MRSBFL-hybrid-max	–	–	–	84.5	
average-case debugging scenario (localize 50% of defective statements)						
1	MCBFL	–	–	–	64.1	
2	MCBFL-hybrid-avg	–	–	–	66.3	
3	MBFL	MUSE ^f	elements	exact	max	68.0
4	MRSBFL	–	–	–	68.5	
10	MRSBFL-hybrid-avg	–	–	–	70.5	
11	MCBFL-hybrid-failover	–	–	–	71.3	
14	MCBFL-hybrid-max	–	–	–	74.0	
16	SBFL	DStar ^f	tests	–	–	74.2
25	MRSBFL-hybrid-failover	–	–	–	75.3	
28	MRSBFL-hybrid-max	–	–	–	75.4	

TABLE XVI
PERCENTAGE OF DEFECTS WHOSE DEFECTIVE STATEMENTS APPEAR
WITHIN THE TOP-5, TOP-10, AND TOP-200 OF THE TECHNIQUES'
SUSPICIOUSNESS RANKING.

Technique	Debugging scenario					
	Best-case dbg. scen.		Worst-case dbg. scen.		Avg-case dbg. scen.	
	Top-5	Top-10	Top-200	Top-5	Top-10	Top-200
MCBFL-hybrid-avg	36%	45%	85%	19%	26%	58%
Metallaxis	29%	39%	77%	16%	22%	47%
DStar	30%	39%	82%	17%	23%	57%
				23%	31%	71%
				18%	27%	63%
				18%	26%	69%

D. The best new technique

We evaluated these novel techniques on our overall set of 395 real faults, considering all debugging scenarios. Overall, MCBFL-hybrid-avg is better than any other technique in all debugging scenarios, but the difference in *EXAM* score and *FLT* rank is not practically significant. This can be seen in fig. 3, which compares the distributions of *EXAM* and absolute scores of the new MCBFL and MRSBFL techniques with the best, existing MBFL and SBFL techniques.

Table XVI compares our new MCBFL-hybrid-avg technique to the best SBFL and MBFL techniques in terms of how often they report defective statements in the top 5, 10, or 200 statements. This is relevant because a recent study [28] showed that 98% of practitioners consider a fault localization technique to be useful only if it reports the defective statement(s) within the top-10 of the suspiciousness ranking. Another analysis [33] shows that automatic program repair systems perform best when they consider only the top-200 suspicious statements.

While the SBFL and MBFL techniques perform equally well under this light, they complement each other. This leads our new MCBFL-hybrid-avg technique to report more defective statements near the top of the suspiciousness ranking than any previous technique.

VIII. THREATS TO VALIDITY

Generalization. Defects4J's data set spans 6 programs, written by different developers and targeting different application domains. Our set of 395 real faults is much larger than all previous studies combined (less than 60 faults). Nonetheless, future research should verify whether our results generalize to other programs and test suites.

Based on the consistency of our results so far (table IV), we believe that artificial faults are not good proxies for real faults, for evaluating any SBFL or MBFL techniques. However, slice-based or model-based techniques (see section IX) are sufficiently different that our results may not carry over to them.

Applicability. The *EXAM* score may not be the best metric for comparing usefulness of FL techniques by humans: in one study, expert programmers diagnosed faults more quickly with FL tools than without, but better *EXAM* scores did not always result in significantly faster debugging [40]. Our study revolves around the *comparison* of FL techniques rather than their absolute performances. Furthermore, our “mean *FLT* rank” metric is agnostic to whether absolute or relative scores are being compared. Other metrics may be better correlated with programmer performance, such as defective statements in the

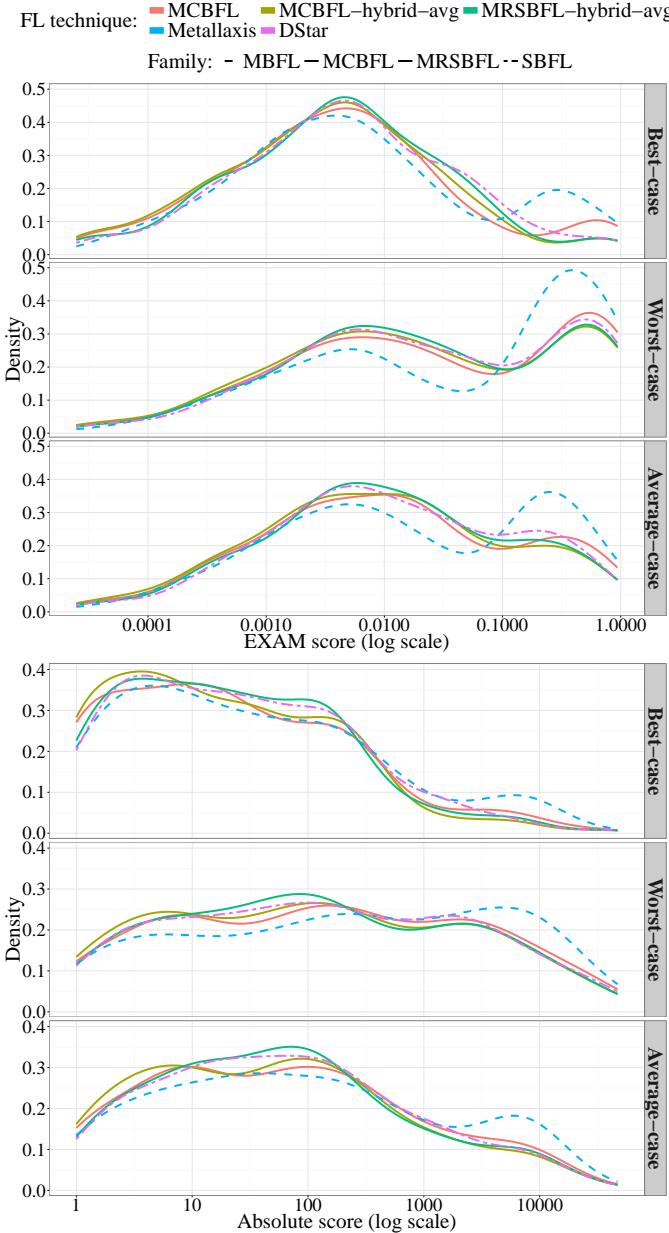


Fig. 3. Distributions of *EXAM* and absolute scores for the new MCBFL and MRSBFL FL techniques. The absolute score is the location of a defective statement in the suspiciousness ranking of program statements, computed by a fault localization technique. The best existing SBFL and MBFL techniques are included as a baseline.

top-10 (section VII-D). It is unknown which metrics are best for other uses of fault localization, such as automated program repair. Even for the use case of human debugging, our study yields insights into the construction and evaluation of FL techniques, and what user studies should be done in the future.

Verifiability. All of our results can be reproduced by an interested reader. Our data and scripts are publicly available at <https://bitbucket.org/rjust/fault-localization-data>. Our methodology builds upon other tools, which are also publicly available. Notable examples are the Defects4J database of

real faults (<https://github.com/rjust/defects4j>), the GZoltar fault localization tool (<http://www.gzoltar.com/>), and the Major mutation framework (<http://mutation-testing.org/>).

IX. RELATED WORK

According to a recent survey [52], the most studied and evaluated fault localization techniques are spectrum-based [4], [20], [29], [51], slice-based [49], [56], model-based [2], [54], and mutation-based [36], [39].

Slice-based techniques [56] use data- and control-flow of a failing execution to identify components that are *not* responsible for triggering a failure and exclude them from a slice. Rather than setting a suspiciousness score to each component as SBFL or MBFL techniques, the aim of slice-based techniques is to reduce the number of components that a developer would have to inspect.

Model-based techniques [2], [34] for fault localization observe executions to infer a model of the software under test; they infer which components could be responsible for faulty behavior using, for example, the oracles provided by test cases. By first applying a spectrum-based technique to remove the components that are likely not related to the observed failure, and then applying a model-based technique on the remaining components, Abreu et al. [1] achieved a better diagnosis when compared to SBFL techniques alone. However, model-based techniques are computationally intractable [35] and do not scale to large software programs.

A. Evaluation of fault localization techniques

a) *Evaluation Studies:* Comparisons of SBFL techniques have been conducted by Jones and Harrold [20], Abreu et al. [4], Le et al. [31], Wong et al. [51], and Santelices et al. [45]. Jones and Harrold compared five spectrum- and slice-based techniques, using the Siemens set of tiny programs to evaluate each. They found their Tarantula formula to be the best, doing significantly better than Nearest-Neighbor [44] (which looks for statements covered by a failing test but not by the most-similar passing test), Set-Union and Set-Intersection (which look for statements executed only by failing tests, or only by passing tests), and Cause Transitions (which looks for statements that change memory in a way that causes failures when transplanted into passing tests during execution). The techniques we studied all resemble Tarantula much more than these other formulas, leading to a more narrowly scoped but more thorough investigation that focuses on the most promising approaches. We found that on artificial faults, Tarantula does significantly worse than any other SBFL technique, and worse than Metallaxis. However, on real faults there is no statistically significant difference between Tarantula and the best SBFL technique.

Abreu et al. [4] considered several different spectrum-based techniques, all identical to Tarantula except in their formulas. They found that Ochiai outperformed all others on the Siemens programs, regardless of the number of passing/failing tests. We compared Tarantula and Ochiai to more formulas and extended them to mutant-based FL as well. Ochiai has also

been evaluated in the context of an embedded TV software stack containing 450KLOC [59]. We confirmed that Ochiai does relatively well on artificial faults, although outperformed by Op2 and DStar.

Le et al. [31] also compared several formulas over the Siemens set, as well on NanoXML, XML-security, and Space; they too find that Ochiai is the best, though not always statistically significantly. It even outperforms three theoretically optimal formulas derived by Xie et al. [55], because the optimality assumptions (e.g., 100% code coverage) are unmet in the studied programs. We do not consider the same set of FL techniques, but we do find Ochiai to be among the best techniques on real faults.

Wong et al. [51] compared over twenty formulas' performances on the Siemens set, grep, make, gzip, and several other real-world programs. They introduce the D^* formula, which typically outperforms all other formulas on all programs they study. They most thoroughly explore D^2 , so we selected it for use here, finding that it outperformed all other techniques in our design space, usually statistically significantly.

Santelices et al. [45] also explored variations on spectrum-based FL, but instead of comparing formulas they compared types of coverage data: statements, branches, and data dependencies. There is no clear winner, but a hybrid of all three modestly outperformed any one individually, evaluated on the Siemens set, NanoXML, and XML-security.

There have been fewer comparisons between spectrum- and mutant-based FL techniques. Papadakis and Le Traon [39], when introducing their mutant-based FL technique Metallaxis, compared it to the spectrum-based equivalent (the “Ochiai” technique in this paper), using the Siemens set. They found that their Metallaxis was consistently superior across several different test suites. We confirmed this finding on artificial faults, but refuted it on real faults.

Moon et al. [36] also performed a cross-family comparison, between their mutation-based technique MUSE and three spectrum-based techniques (Jaccard, Ochiai, and Op2) on flex, grep, gzip, sed, and space. The authors concluded that their MUSE technique typically performs better than the other three. Our results disagree with this finding, due to the fact that mutants rarely fix failing tests on either real faults or many artificial faults.

B. Using developers to evaluate fault localization techniques

Metrics such as T-score, Expense, or EXAM score (see section II-A for more information) were inspired by *perfect fault understanding*: a developer examines statements one-by-one and detects the faulty component when encountering it. Researchers do not believe that programmers actually work this way! Rather, researchers use it as a proxy; they hypothesize that this approach ranks techniques in terms of their true quality.² To understand the perfect fault understanding assumption, Parnin and Orso conducted a preliminary user study on debugging

²This is exactly like researchers do not believe that all real bugs are mutants. Rather, researchers use mutants as a proxy; they hypothesize that ranking based on mutants gives the same results as ranking based on real faults.

effectiveness, involving 34 graduate students [40]. They divided the study participants into two groups, one that used the Tarantula fault localization technique [20] and one that did not. While the results indicate that a fault localization technique helps experienced developers debugging small programs, they do not support the hypothesis that a better ranking significantly affects debugging effectiveness.

More recently, Gouveia et al. [17] also performed a user study to evaluate whether graphical visualizations of the ranking (rather than text [40]) could help developers on debugging. One group used the authors' tool GZoltar [9] and the other group did not. The group that used GZoltar's graphical visualizations of the ranking found the faulty component more often than the control group, and spent less time on debugging.

A recent study [28] surveyed 386 practitioners to access their expectations of automated fault localization techniques. Statement granularity is in the top-3 granularity preferences of practitioners. All fault localization techniques used in this paper (published ones, sections III-A1 and III-A2, and new ones, section VII) are statement-based, i.e., in line with practitioners' opinion. 98% of practitioners say they are not willing to inspect more than 10 statements before finding the true faulty one. For 48% of the total faults, MCBFL-hybrid-avg ranked the faulty line in the top-10. That is, for almost half of the faults used in our study, the 10 first positions of a ranking produced by MCBFL-hybrid-avg included the faulty line.

C. Artificial vs. real faults

It has been very common to evaluate and compare fault localization techniques using manually-seeded artificial faults (e.g., Siemens set [4], [20], [39], [45]) or mutations (e.g., [13], [45], [51]) as a proxy to *real faults*. However, it remains an open question whether results on small artificial faults (whether hand-seeded or automatically-generated) are characteristic of results on real faults.

To the best of our knowledge, previous evaluations of FL techniques on real faults only used one small numerical subject program with simple control flow: space [48], in which 35 real faults were detected during development. Those faults were characterized as: logic omitted or incorrect (e.g., missing condition), computation problems (e.g., incorrect equations), incomplete or incorrect interfaces, and data handling problems (e.g., incorrectly access/store data). In previous studies, space's real faults have been considered alongside artificially inserted faults, but no comparison between the two kinds was done. In contrast, we used larger programs (22–96 KLOC), and we independently evaluated the performance of each FL technique on a larger number of real faults and artificial faults (see section V-A).

The use of mutants as a replacement for real faults has been investigated in other domains. In the context of test prioritization, Do et al. [14] concluded from experiments on six Java programs that mutants are better suited than manually seeded faults for studies of prioritization techniques, as small numbers of hand-selected faults may lead to inappropriate assessments of those techniques. Cifuentes et al. [10] found

that 5 static bug detection tools achieved an average accuracy of 20% on real bugs but 46% on synthetic bugs.

The more general question of whether mutants are representative of real faults has been subject to thorough investigation. While Gopinath et al. [16] found that mutants and real faults are not syntactically similar, several independent studies have provided evidence that mutants and real faults are coupled. DeMillo et al. [12] studied 296 errors in TeX and found simple mutants to be coupled to complex faults. Daran et al. [11] found that the errors caused by 24 mutants on an industrial software program are similar to those of 12 real faults. Andrews et al. [7] compared manually-seeded faults with mutants and concluded that mutants are a good representation of real faults for testing experiments, in contrast to manually-seeded faults. Andrews et al. [8] further evaluated the relation of real faults from the space program and 736 mutants using four mutation operators, and again found that mutants are representative of real faults. Just et al. [24] studied the real faults of the Defects4J [23] data set, and identified a positive correlation of mutant detection with real fault detection. However, they also found that 27% of the real faults in Defects4J [23] are not coupled with commonly used mutation operators [19], suggesting a need for stronger mutation operators.

However, Namin et al. [38] studied the same set of programs as previous studies [7], and cautioned of the substantial external threats to validity when using mutants for experiments. Therefore, it is important to study the impact of the use of mutants for specific types of software engineering experiments, such as fault localization, as conducted in this paper.

X. LESSONS LEARNED

A. Complexity of real faults

Real faults vary in their characteristics far more than artificial faults do, which requires considerable revisions to existing methodology for evaluating FL techniques. For example, with multi-line faults it is nontrivial to identify which statements in the buggy code should be considered defective: declarations and scoping braces are not ranked by most FL techniques, but localizing a closely related statement may be good enough.

B. Debugging scenarios

There may be no single, proper cost model for fault localization effort. A debugging scenario is very likely to be different for humans and automated techniques. For example, a developer might be able to repair a defect after encountering the first defective statement or after encountering 50% of the defective statements on average. An automated repair technique, however, might need to go through all defective statements before being able to generate a patch. Our evaluation acknowledges this challenge and studies the effectiveness of fault localization techniques for multiple debugging scenarios.

C. Efficiency of fault localization techniques

Our analysis does not consider the time it takes to execute each FL technique. MBFL is computationally very costly: our mutation analysis completed in under 32 hours for only 265/395

faults, and in under 168 hours for only 355/395 faults. Note that our implementation avoids unnecessary mutant executions by exploiting several sound optimizations such as mutation coverage information [25] and non-redundant mutation operators [26]. Moreover, for Metallaxis, our implementation is able to determine that the suspiciousness of a mutant is 0 without running all tests on that mutant if no fault-triggering test in the test suite kills that mutant. This optimization reduces Metallaxis’s runtime by a factor of 10. (This can not be done for MUSE, since a mutant’s suspiciousness can be affected by passing tests regardless of whether failing tests kill it.)

The best techniques we found mostly require a mutation analysis of the target program, and for most users, the slight improvement in output quality (compared to SBFL) will not be worth this computational expense. The MRSBFL-hybrid-avg technique we developed is consistently on par with (or slightly superior to) SBFL techniques, but that is the full extent to which we find mutants are useful without incurring these computational costs.

Recall that one of MBFL’s limitations is its inability to rank unmutable statements. In theory, this could be addressed by using a large enough set of mutation operators, including higher-order mutation operators, such that all statements are mutable. This is, however, a very costly solution and might render MBFL as being prohibitively expensive, even for mid-sized programs. Given that an optimized implementation of MBFL did not finish within 168 CPU hours for 10% of real faults, adding many more mutants will only amplify this scalability issue. Furthermore, the benefit of mutating more statements would still be limited to the 10% of real faults that involve statements not mutable by Major’s mutation operators.

XI. CONCLUSION

Fault localization techniques’ performance has mostly been evaluated using artificial faults (e.g., mutants). Artificial faults differ from real faults, so previous studies do not establish which techniques are best at finding real faults.

This paper evaluates the performance of 7 previously-studied fault localization techniques. We replicated previous studies in a systematic way on a larger number of *artificial* faults and on larger subject programs; this confirmed 70% of previous results and falsified 30%. We also evaluated the FL techniques on hundreds of *real* faults, and we found that artificial faults are not useful for predicting which fault localization techniques perform best on real faults. Of the previously-reported results on artificial faults, 60% were statistically insignificant on real faults and the other 40% were falsified; most notably, MBFL techniques are relatively less useful for real faults.

We analyzed the similarities and differences among the FL techniques to synthesize a design space that encompasses them. We evaluated 156 techniques to determine what aspects of a FL technique are most important.

We created new hybrid techniques that outperform previous techniques on the important metric of reporting defects in the top-10 slots of the ranking. The hybrids combine existing

techniques in a way that preserves the complementary strengths of each while mitigating their weaknesses.

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APPENDIX

Figure 4 shows how the *Interaction definition* affects MUSE’s scores for artificial and real faults.

Table XVII provides the results of the replication studies for all debugging scenarios, and figs. 5 and 6 show the distributions of *EXAM* and absolute scores per program.

Table XVIII provides the results of the replication studies for all debugging scenarios, using aggregated results as described in section V-E. Figure 7 shows the distribution of *EXAM* and absolute scores, using aggregated results, and table XIX shows the correlation for these scores between artificial and real faults.

Tables XX and XXI show the top-25 fault localization techniques for real faults, considering all evaluation metrics and all debugging scenarios.

TABLE XVII

EXPANDED VERSION OF TABLE V, WITH DATA FOR ALL DEBUGGING SCENARIOS. THE TABLE CONTAINS PREVIOUSLY-REPORTED COMPARISONS (AS LISTED IN TABLE I), AND OUR RESULTS FOR THOSE COMPARISONS. THE COLUMN “95% CI” GIVES THE CONFIDENCE INTERVAL FOR THE DIFFERENCE IN MEANS AND d GIVES THE EFFECT SIZE (COHEN’S D). THE COLUMN “(B – EQ – W)” GIVES THE COUNTS FOR: PER DEFECT, WAS THE WINNER BETTER, EQUAL TO, OR WORSE COMPARED TO THE LOSER, IGNORING THE MAGNITUDE OF THE DIFFERENCE.

Previous comparisons Winner > loser	Our study on artificial faults				Our study on real faults			
	agree?	d (eff. size)	95% CI	(b – eq – w)	agree?	d (eff. size)	95% CI	(b – eq – w)
best-case debugging scenario (localize any defective statement)								
Ochiai > Tarantula [30], [31], [37], [51], [57]	yes	(-0.24)	[-0.006, -0.005]	(1443–1796–3)	(insig.)	(-0.1)	[-0.004, 0.000]	(75–236–12)
Barinel > Ochiai [5]	no	(0.26)	[0.004, 0.005]	(3–1799–1440)	(insig.)	(0.1)	[-0.000, 0.003]	(12–237–74)
Barinel > Tarantula [5]	yes	(-0.05)	[-0.001, -0.000]	(9–3233–0)	(insig.)	(-0.06)	[-0.003, 0.001]	(1–322–0)
Op2 > Ochiai [37]	yes	(-0.1)	[-0.002, -0.001]	(597–2627–18)	no	(0.14)	[0.002, 0.013]	(65–226–32)
Op2 > Tarantula [36], [37]	yes	(-0.24)	[-0.008, -0.006]	(1522–1702–18)	(insig.)	(0.09)	[-0.001, 0.011]	(81–208–34)
DStar > Ochiai [30], [51]	yes	(-0.11)	[-0.001, -0.000]	(342–2898–2)	(insig.)	(-0.02)	[-0.001, 0.001]	(29–283–11)
DStar > Tarantula [21], [30], [51]	yes	(-0.24)	[-0.007, -0.005]	(1454–1785–3)	(insig.)	(-0.1)	[-0.005, 0.000]	(75–233–15)
Metallaxis > Ochiai [39]	yes	(-0.05)	[-0.017, -0.002]	(2072–240–930)	no	(0.2)	[0.013, 0.043]	(171–18–134)
MUSE > Op2 [36]	no	(0.11)	[0.017, 0.033]	(2030–132–1080)	no	0.79	[0.133, 0.176]	(119–2–202)
MUSE > Tarantula [36]	no	(0.08)	[0.011, 0.026]	(2254–81–907)	no	0.85	[0.139, 0.181]	(115–1–207)
worst-case debugging scenario (localize all defective statements)								
Ochiai > Tarantula [30], [31], [37], [51], [57]	yes	(-0.24)	[-0.006, -0.005]	(1443–1796–3)	(insig.)	(-0.01)	[-0.003, 0.002]	(46–263–14)
Barinel > Ochiai [5]	no	(0.26)	[0.004, 0.005]	(3–1799–1440)	(insig.)	(-0.03)	[-0.003, 0.002]	(14–264–45)
Barinel > Tarantula [5]	yes	(-0.05)	[-0.001, -0.000]	(9–3233–0)	(insig.)	(-0.06)	[-0.003, 0.001]	(1–322–0)
Op2 > Ochiai [37]	yes	(-0.1)	[-0.002, -0.001]	(597–2627–18)	no	(0.26)	[0.010, 0.024]	(52–212–59)
Op2 > Tarantula [36], [37]	yes	(-0.24)	[-0.008, -0.006]	(1522–1702–18)	no	(0.23)	[0.009, 0.024]	(60–201–62)
DStar > Ochiai [30], [51]	yes	(-0.11)	[-0.001, -0.000]	(342–2898–2)	(insig.)	(-0.03)	[-0.000, 0.000]	(17–298–8)
DStar > Tarantula [21], [30], [51]	yes	(-0.24)	[-0.007, -0.005]	(1454–1785–3)	(insig.)	(-0.02)	[-0.003, 0.002]	(47–261–15)
Metallaxis > Ochiai [39]	yes	(-0.05)	[-0.017, -0.002]	(2072–240–930)	no	(0.25)	[0.026, 0.067]	(193–14–116)
MUSE > Op2 [36]	no	(0.11)	[0.017, 0.033]	(2030–132–1080)	no	0.59	[0.116, 0.169]	(132–3–188)
MUSE > Tarantula [36]	no	(0.08)	[0.011, 0.026]	(2254–81–907)	no	0.7	[0.134, 0.184]	(125–1–197)
average-case debugging scenario (localize 50% of defective statements)								
Ochiai > Tarantula [30], [31], [37], [51], [57]	yes	(-0.24)	[-0.006, -0.005]	(1443–1796–3)	(insig.)	(-0.05)	[-0.004, 0.001]	(68–233–22)
Barinel > Ochiai [5]	no	(0.26)	[0.004, 0.005]	(3–1799–1440)	(insig.)	(0.01)	[-0.001, 0.002]	(22–234–67)
Barinel > Tarantula [5]	yes	(-0.05)	[-0.001, -0.000]	(9–3233–0)	(insig.)	(-0.06)	[-0.003, 0.001]	(1–322–0)
Op2 > Ochiai [37]	yes	(-0.1)	[-0.002, -0.001]	(597–2627–18)	no	(0.26)	[0.008, 0.021]	(66–194–63)
Op2 > Tarantula [36], [37]	yes	(-0.24)	[-0.008, -0.006]	(1522–1702–18)	no	(0.21)	[0.007, 0.021]	(80–178–65)
DStar > Ochiai [30], [51]	yes	(-0.11)	[-0.001, -0.000]	(342–2898–2)	(insig.)	(0.07)	[-0.000, 0.001]	(26–279–18)
DStar > Tarantula [21], [30], [51]	yes	(-0.24)	[-0.007, -0.005]	(1454–1785–3)	(insig.)	(-0.03)	[-0.004, 0.002]	(67–230–26)
Metallaxis > Ochiai [39]	yes	(-0.05)	[-0.017, -0.002]	(2072–240–930)	no	(0.21)	[0.015, 0.048]	(187–13–123)
MUSE > Op2 [36]	no	(0.11)	[0.017, 0.033]	(2030–132–1080)	no	0.7	[0.133, 0.183]	(105–2–216)
MUSE > Tarantula [36]	no	(0.08)	[0.011, 0.026]	(2254–81–907)	no	0.82	[0.149, 0.195]	(97–1–225)

Emphasis on whether our study *agrees* indicates p-value: **p<0.01**, p<0.05, (p \geq 0.05).

Emphasis on Cohen’s d indicates effect size: **large**, medium, (small), (*negligible*).

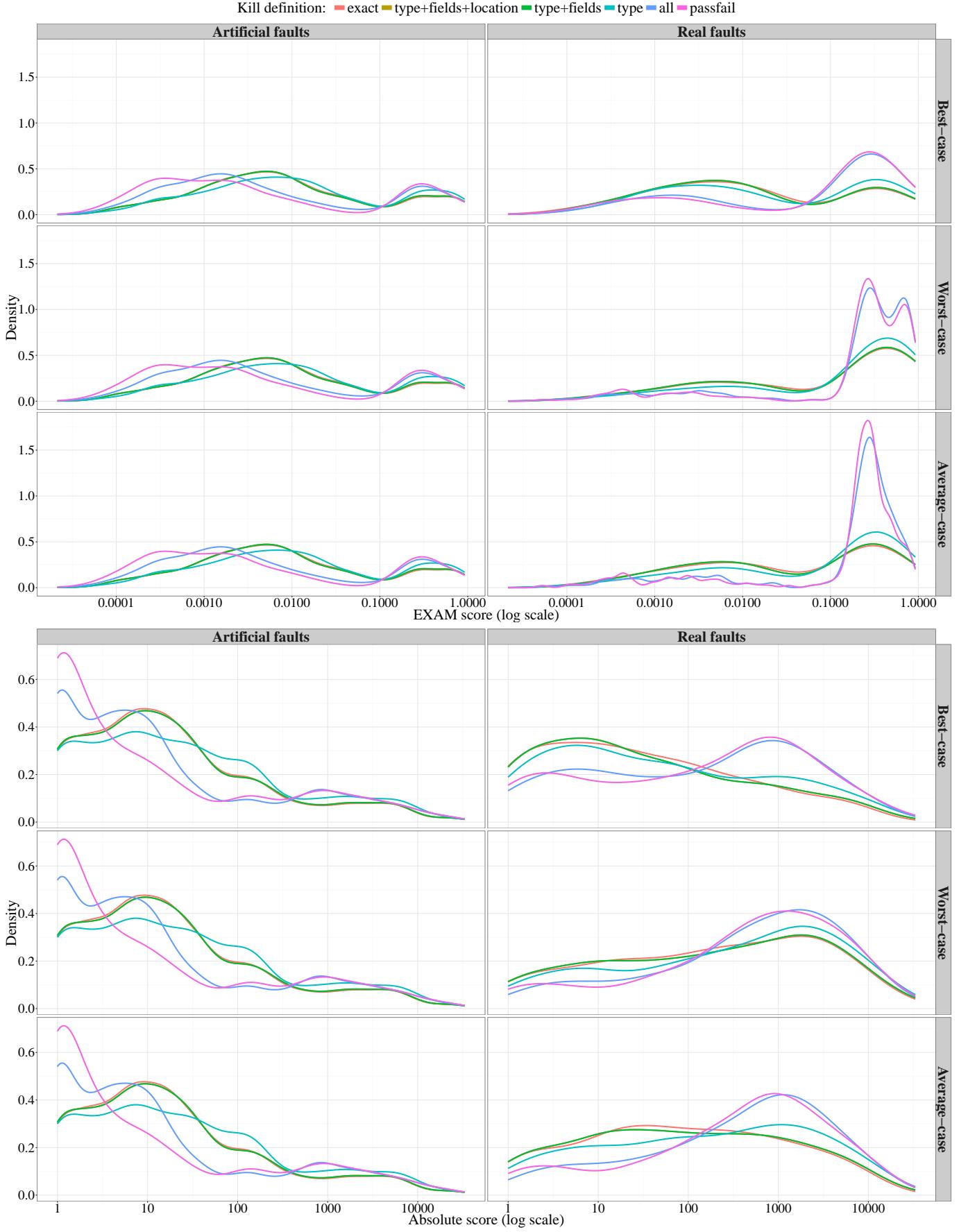


Fig. 4. The effect of the choice of the “Interaction (kill) definition” on MUSE’s EXAM and absolute scores for artificial vs. real faults.

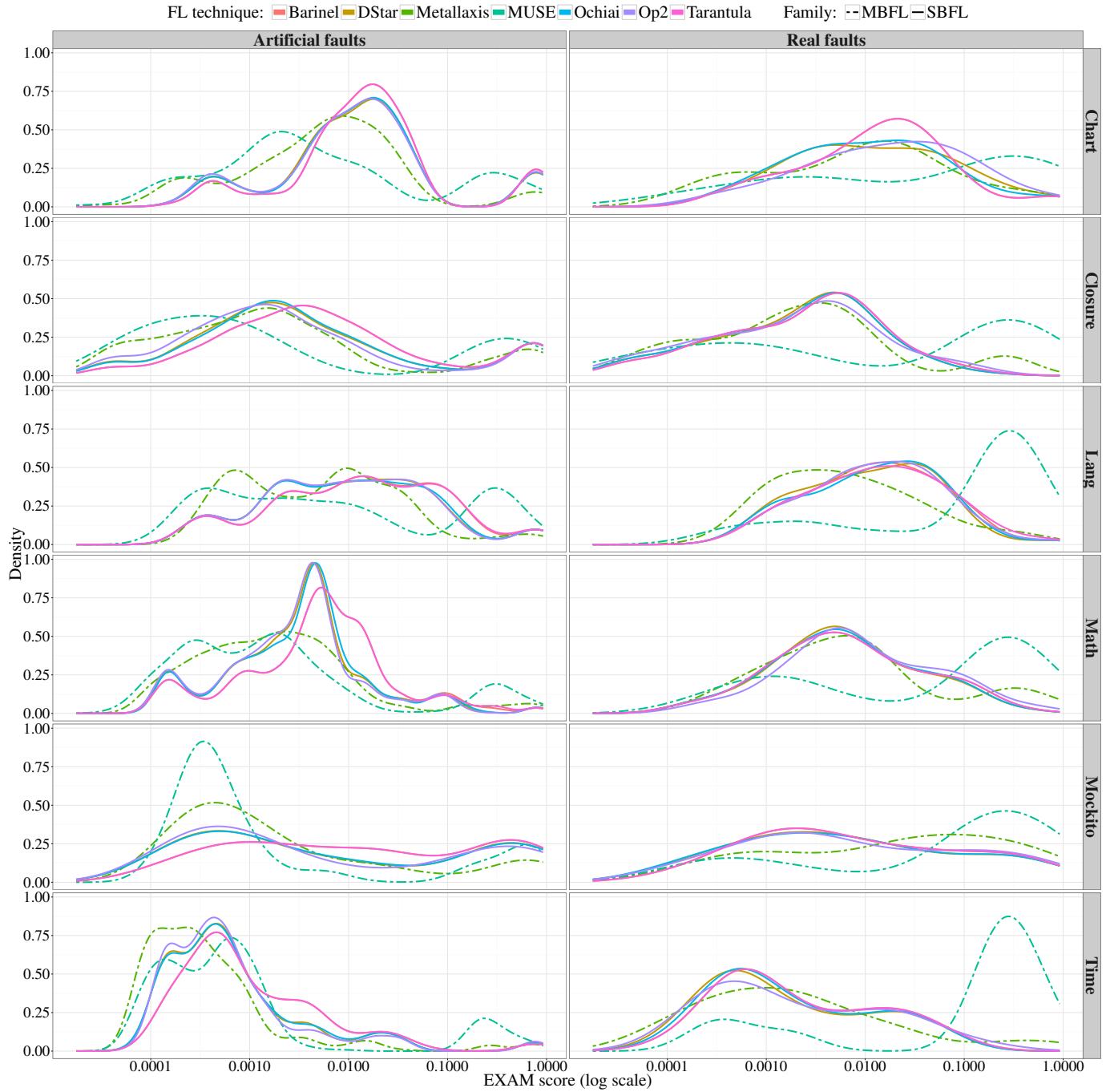


Fig. 5. Distribution of the EXAM scores per program for all fault localization techniques and artificial vs. real faults.

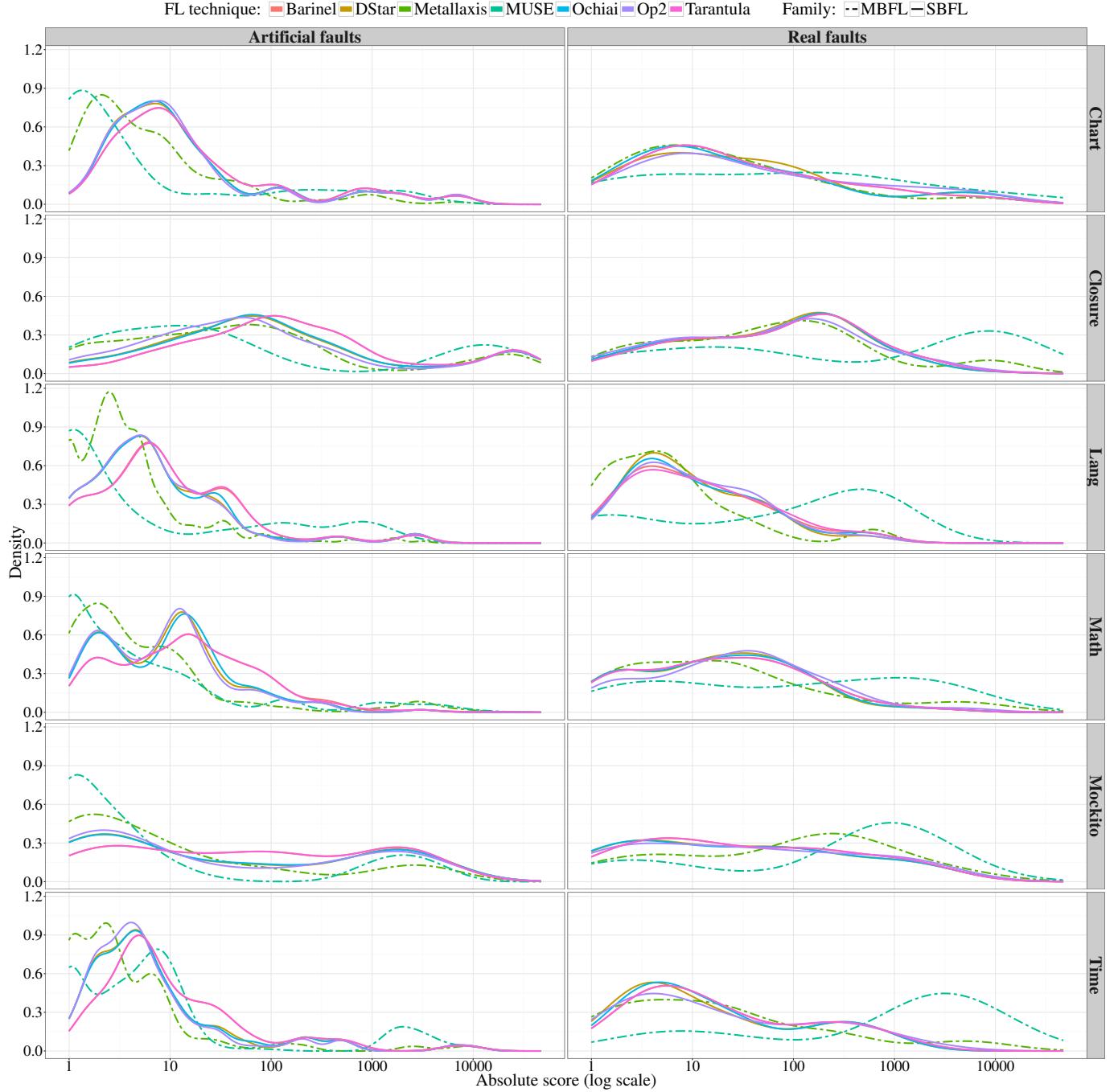


Fig. 6. Distribution of the absolute scores per program for all fault localization techniques and artificial vs. real faults. The absolute score is the location of the defective statement in the suspiciousness ranking of program statements, computed by a fault localization technique.

TABLE XVIII

ALTERNATIVE, EXPANDED VERSION OF TABLE V, AVERAGING EACH FL TECHNIQUE'S SCORES OVER THE ARTIFICIAL FAULTS CORRESPONDING TO EACH REAL FAULT AS DESCRIBED IN SECTION V-E. THE TABLE CONTAINS PREVIOUSLY-REPORTED COMPARISONS (AS LISTED IN TABLE I), AND OUR RESULTS FOR THOSE COMPARISONS. THE COLUMN "95% CI" GIVES THE CONFIDENCE INTERVAL FOR THE DIFFERENCE IN MEANS AND d GIVES THE EFFECT SIZE (COHEN'S d). THE COLUMN "(B - EQ - W)" GIVES THE COUNTS FOR: PER DEFECT, WAS THE WINNER BETTER, EQUAL TO, OR WORSE COMPARED TO THE LOSER, IGNORING THE MAGNITUDE OF THE DIFFERENCE.

Previous comparisons Winner > loser	Our study on artificial faults				Our study on real faults			
	agree?	d (eff. size)	95% CI	(b - eq - w)	agree?	d (eff. size)	95% CI	(b - eq - w)
best-case debugging scenario (localize any defective statement)								
Ochiai > Tarantula [30], [31], [37], [51], [57]	yes	(-0.33)	[-0.007, -0.004]	(224–97–2)	(insig.)	(-0.1)	[-0.004, 0.000]	(75–236–12)
Barinel > Ochiai [5]	no	(0.36)	[0.003, 0.006]	(2–97–224)	(insig.)	(0.1)	[-0.000, 0.003]	(12–237–74)
Barinel > Tarantula [5]	(insig.)	(-0.08)	[-0.001, 0.000]	(2–321–0)	(insig.)	(-0.06)	[-0.003, 0.001]	(1–322–0)
Op2 > Ochiai [37]	(insig.)	(-0.11)	[-0.004, 0.000]	(145–167–11)	no	(0.14)	[0.002, 0.013]	(65–226–32)
Op2 > Tarantula [36], [37]	yes	(-0.29)	[-0.010, -0.004]	(226–86–11)	(insig.)	(0.09)	[-0.001, 0.011]	(81–208–34)
DStar > Ochiai [30], [51]	yes	(-0.13)	[-0.000, -0.000]	(105–216–2)	(insig.)	(-0.02)	[-0.001, 0.001]	(29–283–11)
DStar > Tarantula [21], [30], [51]	yes	(-0.32)	[-0.008, -0.004]	(226–95–2)	(insig.)	(-0.1)	[-0.005, 0.000]	(75–233–15)
Metallaxis > Ochiai [39]	(insig.)	(0.04)	[-0.017, 0.036]	(196–6–121)	no	(0.2)	[0.013, 0.043]	(171–18–134)
MUSE > Op2 [36]	no	(0.17)	[0.015, 0.070]	(147–3–173)	no	0.79	[0.133, 0.176]	(119–2–202)
MUSE > Tarantula [36]	no	(0.14)	[0.008, 0.063]	(161–1–161)	no	0.85	[0.139, 0.181]	(115–1–207)
worst-case debugging scenario (localize all defective statements)								
Ochiai > Tarantula [30], [31], [37], [51], [57]	yes	(-0.33)	[-0.007, -0.004]	(224–97–2)	(insig.)	(-0.01)	[-0.003, 0.002]	(46–263–14)
Barinel > Ochiai [5]	no	(0.36)	[0.003, 0.006]	(2–97–224)	(insig.)	(-0.03)	[-0.003, 0.002]	(14–264–45)
Barinel > Tarantula [5]	(insig.)	(-0.08)	[-0.001, 0.000]	(2–321–0)	(insig.)	(-0.06)	[-0.003, 0.001]	(1–322–0)
Op2 > Ochiai [37]	(insig.)	(-0.11)	[-0.004, 0.000]	(145–167–11)	no	(0.26)	[0.010, 0.024]	(52–212–59)
Op2 > Tarantula [36], [37]	yes	(-0.29)	[-0.010, -0.004]	(226–86–11)	no	(0.23)	[0.009, 0.024]	(60–201–62)
DStar > Ochiai [30], [51]	yes	(-0.13)	[-0.000, -0.000]	(105–216–2)	(insig.)	(-0.03)	[-0.000, 0.000]	(17–298–8)
DStar > Tarantula [21], [30], [51]	yes	(-0.32)	[-0.008, -0.004]	(226–95–2)	(insig.)	(-0.02)	[-0.003, 0.002]	(47–261–15)
Metallaxis > Ochiai [39]	(insig.)	(0.04)	[-0.017, 0.036]	(196–6–121)	no	(0.25)	[0.026, 0.067]	(193–14–116)
MUSE > Op2 [36]	no	(0.17)	[0.015, 0.070]	(147–3–173)	no	0.59	[0.116, 0.169]	(132–3–188)
MUSE > Tarantula [36]	no	(0.14)	[0.008, 0.063]	(161–1–161)	no	0.7	[0.134, 0.184]	(125–1–197)
average-case debugging scenario (localize 50% of defective statements)								
Ochiai > Tarantula [30], [31], [37], [51], [57]	yes	(-0.33)	[-0.007, -0.004]	(224–97–2)	(insig.)	(-0.05)	[-0.004, 0.001]	(68–233–22)
Barinel > Ochiai [5]	no	(0.36)	[0.003, 0.006]	(2–97–224)	(insig.)	(0.01)	[-0.001, 0.002]	(22–234–67)
Barinel > Tarantula [5]	(insig.)	(-0.08)	[-0.001, 0.000]	(2–321–0)	(insig.)	(-0.06)	[-0.003, 0.001]	(1–322–0)
Op2 > Ochiai [37]	(insig.)	(-0.11)	[-0.004, 0.000]	(145–167–11)	no	(0.26)	[0.008, 0.021]	(66–194–63)
Op2 > Tarantula [36], [37]	yes	(-0.29)	[-0.010, -0.004]	(226–86–11)	no	(0.21)	[0.007, 0.021]	(80–178–65)
DStar > Ochiai [30], [51]	yes	(-0.13)	[-0.000, -0.000]	(105–216–2)	(insig.)	(0.07)	[-0.000, 0.001]	(26–279–18)
DStar > Tarantula [21], [30], [51]	yes	(-0.32)	[-0.008, -0.004]	(226–95–2)	(insig.)	(-0.03)	[-0.004, 0.002]	(67–230–26)
Metallaxis > Ochiai [39]	(insig.)	(0.04)	[-0.017, 0.036]	(196–6–121)	no	(0.21)	[0.015, 0.048]	(187–13–123)
MUSE > Op2 [36]	no	(0.17)	[0.015, 0.070]	(147–3–173)	no	0.7	[0.133, 0.183]	(105–2–216)
MUSE > Tarantula [36]	no	(0.14)	[0.008, 0.063]	(161–1–161)	no	0.82	[0.149, 0.195]	(97–1–225)

Emphasis on whether our study *agrees* indicates p-value: **p<0.01**, p<0.05, ($p \geq 0.05$).

Emphasis on Cohen's d indicates effect size: **large**, medium, (small), (*negligible*).

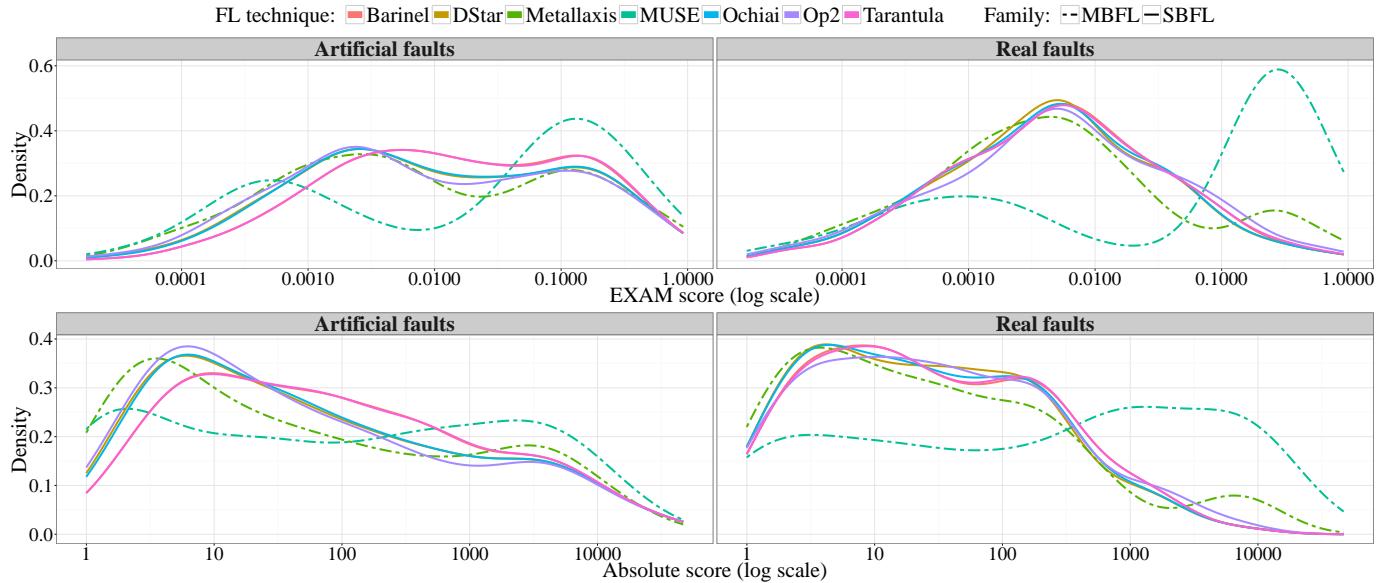


Fig. 7. Distributions of *EXAM* and absolute scores for all FL techniques, considering the best-case debugging scenario and averaging each FL technique's scores across the artificial faults corresponding to each real fault as described in section V-E. The absolute score is the first location of any defective statement in the suspiciousness ranking of program statements, computed by a fault localization technique.

TABLE XX
TOP-25 FL TECHNIQUES ACCORDING TO MEAN EXAM SCORE.

	Family	Formula	Total def.	Kill def.	Agg. def.	EXAM score
best-case debugging scenario (localize any defective statement)						
1	MCBFL-hybrid-avg	—	—	—	—	0.034 273
2	MCBFL-hybrid-max	—	—	—	—	0.034 652
3	MRSBFL-hybrid-max	—	—	—	—	0.035 594
4	MRSBFL-hybrid-avg	—	—	—	—	0.036 099
5	MCBFL-hybrid-failover	—	—	—	—	0.039 445
6	SBFL	DStar ^f tests	—	—	—	0.040 031
7	SBFL	Ochiai ^f elements	—	—	—	0.040 171
8	SBFL	Ochiai ^f tests	—	—	—	0.040 171
9	SBFL	Barinel ^f elements	—	—	—	0.041 179
10	SBFL	Barinel ^f tests	—	—	—	0.041 179
11	MRSBFL-hybrid-failover	—	—	—	—	0.041 284
12	SBFL	Tarantula ^f elements	—	—	—	0.042 541
13	SBFL	Tarantula ^f tests	—	—	—	0.042 541
14	SBFL	MUSE ^f tests	—	—	—	0.045 754
15	SBFL	DStar ^f elements	—	—	—	0.046 333
16	SBFL	Op2 ^f elements	—	—	—	0.047 095
17	SBFL	Op2 ^f tests	—	—	—	0.047 095
18	SBFL	MUSE ^f elements	—	—	—	0.049 692
19	MCBFL	—	—	—	—	0.057 708
20	MRSBFL	—	—	—	—	0.059 736
21	MBFL	Ochiai ^f elements	exact	max	max	0.077 750
22	MBFL	Ochiai ^f tests	exact	max	max	0.077 750
23	MBFL	DStar ^f tests	exact	max	max	0.077 887
24	MBFL	Barinel ^f elements	exact	max	max	0.078 239
25	MBFL	Barinel ^f tests	exact	max	max	0.078 239
worst-case debugging scenario (localize all defective statements)						
1	MRSBFL-hybrid-max	—	—	—	—	0.182 354
2	MCBFL-hybrid-max	—	—	—	—	0.182 442
3	MCBFL-hybrid-avg	—	—	—	—	0.182 685
4	MRSBFL-hybrid-avg	—	—	—	—	0.183 279
5	MRSBFL-hybrid-failover	—	—	—	—	0.184 189
6	MCBFL-hybrid-failover	—	—	—	—	0.184 376
7	SBFL	Barinel ^f elements	—	—	—	0.190 808
8	SBFL	Barinel ^f tests	—	—	—	0.190 808
9	SBFL	DStar ^f tests	—	—	—	0.191 249
10	SBFL	Ochiai ^f elements	—	—	—	0.191 270
11	SBFL	Ochiai ^f tests	—	—	—	0.191 270
12	SBFL	Tarantula ^f elements	—	—	—	0.192 170
13	SBFL	Tarantula ^f tests	—	—	—	0.192 170
14	SBFL	DStar ^f elements	—	—	—	0.196 445
15	SBFL	Op2 ^f elements	—	—	—	0.205 877
16	SBFL	Op2 ^f tests	—	—	—	0.205 877
17	SBFL	MUSE ^f tests	—	—	—	0.207 051
18	SBFL	MUSE ^f elements	—	—	—	0.207 254
19	MCBFL	—	—	—	—	0.213 465
20	MRSBFL	—	—	—	—	0.213 583
21	MBFL	Ochiai ^f elements	exact	max	max	0.244 846
22	MBFL	Ochiai ^f tests	exact	max	max	0.244 846
23	MBFL	Barinel ^f elements	exact	max	max	0.245 028
24	MBFL	Barinel ^f tests	exact	max	max	0.245 028
25	MBFL	Barinel ^f elements	exact	avg	avg	0.245 619
average-case debugging scenario (localize 50% of defective statements)						
1	MCBFL-hybrid-avg	—	—	—	—	0.082 335
2	MCBFL-hybrid-max	—	—	—	—	0.082 912
3	MRSBFL-hybrid-max	—	—	—	—	0.083 747
4	MRSBFL-hybrid-avg	—	—	—	—	0.084 281
5	MCBFL-hybrid-failover	—	—	—	—	0.084 719
6	MRSBFL-hybrid-failover	—	—	—	—	0.086 221
7	SBFL	Ochiai ^f elements	—	—	—	0.087 853
8	SBFL	Ochiai ^f tests	—	—	—	0.087 853
9	SBFL	Barinel ^f elements	—	—	—	0.088 084
10	SBFL	Barinel ^f tests	—	—	—	0.088 084
11	SBFL	DStar ^f tests	—	—	—	0.088 122
12	SBFL	Tarantula ^f elements	—	—	—	0.089 446
13	SBFL	Tarantula ^f tests	—	—	—	0.089 446
14	SBFL	DStar ^f elements	—	—	—	0.095 001
15	SBFL	Op2 ^f elements	—	—	—	0.100 237
16	SBFL	Op2 ^f tests	—	—	—	0.100 237
17	SBFL	MUSE ^f tests	—	—	—	0.101 176
18	SBFL	MUSE ^f elements	—	—	—	0.102 478
19	MCBFL	—	—	—	—	0.104 059
20	MRSBFL	—	—	—	—	0.106 036
21	MBFL	DStar ^f tests	exact	max	max	0.128 669
22	MBFL	Ochiai ^f elements	exact	max	max	0.128 695
23	MBFL	Ochiai ^f tests	exact	max	max	0.128 695
24	MBFL	Barinel ^f elements	exact	max	max	0.128 732
25	MBFL	Barinel ^f tests	exact	max	max	0.128 732

TABLE XIX

PEARSON'S r AND SPEARMAN'S ρ CORRELATION COEFFICIENTS FOR THE AGGREGATED EXAM SCORE AND FLT RANK BETWEEN ARTIFICIAL AND REAL FAULTS.

Technique	EXAM Score		FLT rank	
	r	ρ	r	ρ
best-case debugging scenario				
Ochiai	0.2	0.43	0.32	0.33
Tarantula	0.22	0.45	0.41	0.41
Barinel	0.22	0.45	0.43	0.43
Op2	0.16	0.3	0.34	0.35
DStar	0.2	0.42	0.29	0.3
Metallaxis	0.04	0.32	0.28	0.26
MUSE	0.14	0.16	0.29	0.27
worst-case debugging scenario				
Ochiai	0.02	0.29	0.17	0.2
Tarantula	0.03	0.34	0.27	0.26
Barinel	0.03	0.34	0.28	0.27
Op2	0.02	0.2	0.16	0.13
DStar	0.02	0.28	0.15	0.17
Metallaxis	0.13	0.3	0.12	0.14
MUSE	0.16	0.2	0.22	0.23
average-case debugging scenario				
Ochiai	0.03	0.31	0.2	0.23
Tarantula	0.05	0.37	0.32	0.31
Barinel	0.05	0.37	0.34	0.33
Op2	0.02	0.21	0.27	0.28
DStar	0.03	0.3	0.2	0.22
Metallaxis	0.1	0.36	0.19	0.21
MUSE	0.15	0.2	0.28	0.26

TABLE XXI

TOP-25 FL TECHNIQUES ACCORDING TO MEAN FLT RANK.

Family	Formula	Total def.	Kill def.	Agg. def.	FLT rank
best-case debugging scenario (localize any defective statement)					
1	MCBFL	—	—	—	64.9
2	MCBFL-hybrid-avg	—	—	—	66.3
3	MRSBFL	—	—	—	71.3
4	MRSBFL-hybrid-avg	—	—	—	71.6
5	MCBFL-hybrid-failover	—	—	—	71.8
6	MBFL	DStar ^f	tests	type	avg 72.2
7	MBFL	MUSE ^f	elements	exact	avg 72.5
8	MBFL	MUSE ^f	elements	type+fields	avg 72.8
9	MBFL	MUSE ^f	elements	type+fields+location	avg 72.8
10	MBFL	DStar ^f	tests	type+fields	avg 74.3
11	MBFL	DStar ^f	tests	type+fields+location	avg 74.3
12	MBFL	MUSE ^f	elements	type	max 74.3
13	MBFL	DStar ^f	tests	exact	avg 75.3
14	MBFL	MUSE ^f	tests	type+fields	avg 75.4
15	MBFL	MUSE ^f	tests	type+fields+location	avg 75.4
16	MBFL	Ochiai ^f	elements	type+fields	avg 75.8
17	MBFL	Ochiai ^f	elements	type+fields+location	avg 75.8
18	MBFL	Barinel ^f	elements	type	avg 75.8
19	MBFL	Barinel ^f	tests	type	avg 75.8
20	MBFL	MUSE ^f	tests	exact	avg 75.9
21	MBFL	Ochiai ^f	tests	type+fields	avg 76.0
22	MBFL	Ochiai ^f	tests	type+fields+location	avg 76.0
23	MBFL	DStar ^f	tests	type	max 76.0
24	MBFL	Ochiai ^f	elements	type	max 76.3
25	MBFL	Ochiai ^f	tests	type	max 76.3
worst-case debugging scenario (localize all defective statements)					
1	MCBFL	—	—	—	69.8
2	MBFL	MUSE ^f	elements	exact	max 71.1
3	MBFL	MUSE ^f	elements	exact	avg 71.1
4	MBFL	MUSE ^f	elements	type+fields	max 71.6
5	MBFL	MUSE ^f	elements	type+fields+location	max 71.6
6	MRSBFL	—	—	—	71.7
7	MBFL	MUSE ^f	elements	type+fields	avg 71.9
8	MBFL	MUSE ^f	elements	type+fields+location	avg 71.9
9	MBFL	MUSE ^f	elements	type	max 72.1
10	MBFL	Ochiai ^f	elements	passfail	max 72.7
11	MBFL	Ochiai ^f	tests	passfail	max 72.7
12	MBFL	DStar ^f	tests	passfail	max 72.7
13	MBFL	Barinel ^f	elements	passfail	max 73.1
14	MBFL	Barinel ^f	tests	passfail	max 73.1
15	MBFL	DStar ^f	tests	passfail	avg 73.2
16	MBFL	Tarantula ^f	tests	passfail	max 73.4
17	MBFL	Barinel ^f	elements	passfail	avg 73.5
18	MBFL	Barinel ^f	tests	passfail	avg 73.5
19	MBFL	Tarantula ^f	elements	passfail	max 73.6
20	MBFL	Ochiai ^f	tests	passfail	avg 74.4
21	MBFL	Ochiai ^f	elements	passfail	avg 74.4
22	MBFL	Tarantula ^f	tests	passfail	avg 76.0
23	MBFL	MUSE ^f	tests	type	max 76.3
24	MBFL	Tarantula ^f	elements	passfail	avg 76.8
25	MBFL	DStar ^f	tests	type	max 76.9
average-case debugging scenario (localize 50% of defective statements)					
1	MCBFL	—	—	—	64.1
2	MCBFL-hybrid-avg	—	—	—	66.3
3	MBFL	MUSE ^f	elements	exact	max 68.0
4	MRSBFL	—	—	—	68.5
5	MBFL	MUSE ^f	elements	exact	avg 68.9
6	MBFL	MUSE ^f	elements	type+fields	max 69.3
7	MBFL	MUSE ^f	elements	type+fields+location	max 69.3
8	MBFL	MUSE ^f	elements	type+fields	avg 70.1
9	MBFL	MUSE ^f	elements	type+fields+location	avg 70.1
10	MRSBFL-hybrid-avg	—	—	—	70.5
11	MCBFL-hybrid-failover	—	—	—	71.3
12	MBFL	MUSE ^f	elements	type	max 73.0
13	MBFL	MUSE ^f	tests	exact	max 73.3
14	MCBFL-hybrid-max	—	—	—	74.0
15	MBFL	MUSE ^f	tests	exact	avg 74.2
16	SBFL	DStar ^f	tests	—	74.2
17	SBFL	Ochiai ^f	elements	—	74.3
18	SBFL	Ochiai ^f	tests	—	74.3
19	SBFL	MUSE ^f	elements	—	74.6
20	MBFL	MUSE ^f	tests	type+fields	avg 74.6
21	MBFL	MUSE ^f	tests	type+fields+location	avg 74.6
22	MBFL	MUSE ^f	tests	type+fields	max 74.8
23	MBFL	MUSE ^f	tests	type+fields+location	max 74.8
24	SBFL	MUSE ^f	tests	—	75.1
25	MRSBFL-hybrid-failover	—	—	—	75.3